

# LME49870

## 44V Single High Performance, High Fidelity Audio Operational Amplifier

### General Description

The LME49870 is part of the ultra-low distortion, low noise, high slew rate operational amplifier series optimized and fully specified for high performance, high fidelity applications. Combining advanced leading-edge process technology with state-of-the-art circuit design, the LME49870 audio operational amplifier delivers superior audio signal amplification for outstanding audio performance. The LME49870 combines extremely low voltage noise density ( $2.7\text{nV}/\sqrt{\text{Hz}}$ ) with vanishingly low THD+N (0.00003%) to easily satisfy the most demanding audio applications. To ensure that the most challenging loads are driven without compromise, the LME49870 has a high slew rate of  $\pm 20\text{V}/\mu\text{s}$  and an output current capability of  $\pm 26\text{mA}$ . Further, dynamic range is maximized by an output stage that drives  $2\text{k}\Omega$  loads to within 1V of either power supply voltage and to within 1.4V when driving  $600\Omega$  loads.

The LME49870's outstanding CMRR (120dB), PSRR (120dB), and  $V_{\text{OS}}$  (0.1mV) give the amplifier excellent operational amplifier DC performance.

The LME49870 has a wide supply range of  $\pm 2.5\text{V}$  to  $\pm 22\text{V}$ . Over this supply range the LME49870 maintains excellent common-mode rejection, power supply rejection, and low input bias current. The LME49870 is unity gain stable. This Audio Operational Amplifier achieves outstanding AC performance while driving complex loads with values as high as 100pF.

The LME49870 is available in 8-lead narrow body SOIC. Demonstration boards are available for each package.

### Key Specifications

- Power Supply Voltage Range  $\pm 2.5\text{V}$  to  $\pm 22\text{V}$
- THD+N  
( $A_V = 1$ ,  $V_{\text{OUT}} = 3V_{\text{RMS}}$ ,  $f_{\text{IN}} = 1\text{kHz}$ )

$R_L = 2\text{k}\Omega$	0.00003% (typ)
$R_L = 600\Omega$	0.00003% (typ)
■ Input Noise Density	$2.7\text{nV}/\sqrt{\text{Hz}}$ (typ)
■ Slew Rate	$\pm 20\text{V}/\mu\text{s}$ (typ)
■ Gain Bandwidth Product	55MHz (typ)
■ Open Loop Gain ( $R_L = 600\Omega$ )	140dB (typ)
■ Input Bias Current	10nA (typ)
■ Input Offset Voltage	0.1mV (typ)
■ DC Gain Linearity Error	0.000009%

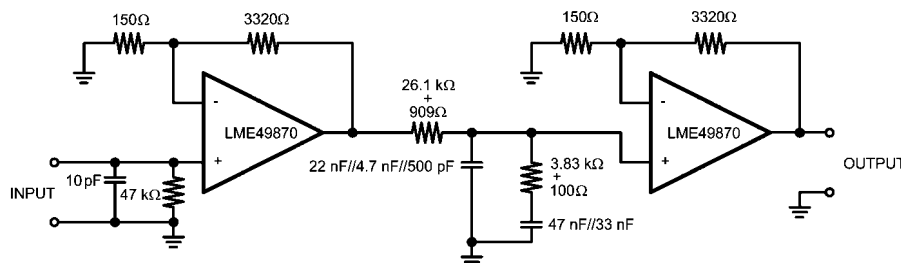
### Features

- Easily drives  $600\Omega$  loads
- Optimized for superior audio signal fidelity
- Output short circuit protection
- PSRR and CMRR exceed 120dB (typ)

### Applications

- High quality audio amplification
- High fidelity preamplifiers, phono preamps, and multimedia
- High performance professional audio
- High fidelity equalization and crossover networks with active filters
- High performance line drivers and receivers
- Low noise industrial applications including test, measurement, and ultrasound

### Typical Application

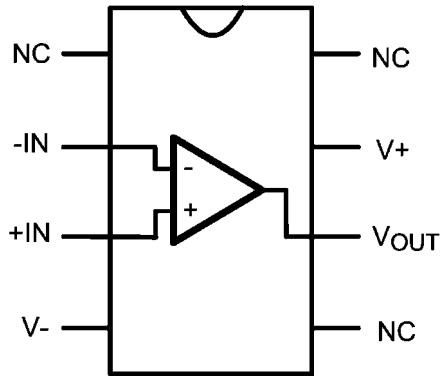


Note: 1% metal film resistors, 5% polypropylene capacitors

Passively Equalized RIAA Phono Preamp

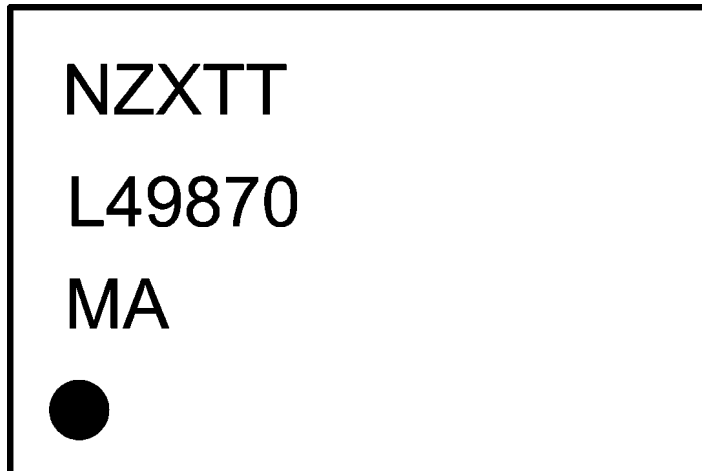
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## Connection Diagrams



Order Number LME49870MA  
See NS Package Number — M08A

LME49870 Top Mark



N — National Logo  
Z — Assembly Plant code  
X — 1 Digit Date code  
TT — Die Traceability  
L49870 — LME49870  
MA — Package code

**Absolute Maximum Ratings** (Notes 1, 2)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/ Distributors for availability and specifications.

Power Supply Voltage ( $V_S = V^+ - V^-$ )	46V
Storage Temperature	-65°C to 150°C
Input Voltage	(V-) - 0.7V to (V+) + 0.7V
Output Short Circuit (Note 3)	Continuous
Power Dissipation	Internally Limited
ESD Rating (Note 4)	2000V
ESD Rating (Note 5)	

Pins 1, 4, 7 and 8	200V
Pins 2, 3, 5 and 6	100V
Junction Temperature	150°C
Thermal Resistance	
$\theta_{JA}$ (SO)	145°C/W

**Operating Ratings**

Temperature Range	$T_{MIN} \leq T_A \leq T_{MAX}$	$-40^\circ\text{C} \leq T_A \leq 85^\circ\text{C}$
Supply Voltage Range		$\pm 2.5\text{V} \leq V_S \leq \pm 22\text{V}$

**Electrical Characteristics for the LME49870** (Note 1) The following specifications apply for  $V_S = \pm 18\text{V}$  and  $\pm 22\text{V}$ ,  $R_L = 2\text{k}\Omega$ ,  $R_{SOURCE} = 10\Omega$ ,  $f_{IN} = 1\text{kHz}$ ,  $T_A = 25^\circ\text{C}$ , unless otherwise specified.

Symbol	Parameter	Conditions	LME49870		Units (Limits)
			Typical	Limit	
			(Note 6)	(Note 7)	
THD+N	Total Harmonic Distortion + Noise	$A_V = 1$ , $V_{OUT} = 3V_{rms}$ $R_L = 2\text{k}\Omega$ $R_L = 600\Omega$	0.00003 0.00003	0.00009	% (max)
IMD	Intermodulation Distortion	$A_V = 1$ , $V_{OUT} = 3V_{RMS}$ Two-tone, 60Hz & 7kHz 4:1	0.00005		%
GBWP	Gain Bandwidth Product		55	45	MHz (min)
SR	Slew Rate		$\pm 20$	$\pm 15$	V/ $\mu\text{s}$ (min)
FPBW	Full Power Bandwidth	$V_{OUT} = 1V_{P-P}$ , -3dB referenced to output magnitude at $f = 1\text{kHz}$	10		MHz
$t_s$	Settling time	$A_V = -1$ , 10V step, $C_L = 100\text{pF}$ 0.1% error range	1.2		$\mu\text{s}$
$e_n$	Equivalent Input Noise Voltage	$f_{BW} = 20\text{Hz}$ to 20kHz	0.34	0.65	$\mu\text{V}_{RMS}$ (max)
	Equivalent Input Noise Density	$f = 1\text{kHz}$ $f = 10\text{Hz}$	2.5 6.4	4.7	nV/ $\sqrt{\text{Hz}}$ (max)
$i_n$	Current Noise Density	$f = 1\text{kHz}$ $f = 10\text{Hz}$	1.6 3.1		pA/ $\sqrt{\text{Hz}}$
$V_{OS}$	Offset Voltage	$V_S = \pm 18\text{V}$	$\pm 0.12$		mV (max)
		$V_S = \pm 22\text{V}$	$\pm 0.14$	$\pm 0.7$	mV (max)
$\Delta V_{OS}/\Delta\text{Temp}$	Average Input Offset Voltage Drift vs Temperature	$-40^\circ\text{C} \leq T_A \leq 85^\circ\text{C}$	0.1		$\mu\text{V}/^\circ\text{C}$
PSRR	Average Input Offset Voltage Shift vs Power Supply Voltage	$V_S = \pm 18\text{V}$ , $\Delta V_S = 24\text{V}$ (Note 8)	120		dB (min)
		$V_S = \pm 22\text{V}$ , $\Delta V_S = 30\text{V}$	120	110	
$I_B$	Input Bias Current	$V_{CM} = 0\text{V}$	10	72	nA (max)
$\Delta I_{OS}/\Delta\text{Temp}$	Input Bias Current Drift vs Temperature	$-40^\circ\text{C} \leq T_A \leq 85^\circ\text{C}$	0.2		nA/ $^\circ\text{C}$
$I_{OS}$	Input Offset Current	$V_{CM} = 0\text{V}$	11	65	nA (max)
$V_{IN-CM}$	Common-Mode Input Voltage Range	$V_S = \pm 18\text{V}$	+17.1 -16.9		V (min) V (min)
		$V_S = \pm 22\text{V}$	+21.0 -20.8	(V+) - 2.0 (V-) + 2.0	V (min) V (min)

Symbol	Parameter	Conditions	LME49870		Units (Limits)
			Typical	Limit	
			(Note 6)	(Note 7)	
CMRR	Common-Mode Rejection	$V_S = \pm 18V$ $-12V \leq V_{cm} \leq 12V$	120		dB (min)
		$V_S = \pm 22V$ $-15V \leq V_{cm} \leq 15V$	120	110	dB (min)
$Z_{IN}$	Differential Input Impedance		30		$k\Omega$
	Common Mode Input Impedance	$-10V < V_{cm} < 10V$	1000		$M\Omega$
$A_{VOL}$	Open Loop Voltage Gain	$V_S = \pm 18V$ $-12V \leq V_{out} \leq 12V$ $R_L = 600\Omega$ $R_L = 2k\Omega$ $R_L = 10\Omega$	140 140 140		dB dB dB
		$V_S = \pm 22V$ $-15V \leq V_{out} \leq 15V$ $R_L = 600\Omega$ $R_L = 2k\Omega$ $R_L = 10\Omega$	140 140 140	125	dB dB dB
		$R_L = 600\Omega$ $V_S = \pm 18V$ $V_S = \pm 22V$	$\pm 16.7$ $\pm 20.4$	$\pm 19.0$	V (min) V (min)
		$R_L = 2k\Omega$ $V_S = \pm 18V$ $V_S = \pm 22V$	$\pm 17.0$ $\pm 21.0$		V (min) V (min)
$V_{OUTMAX}$	Maximum Output Voltage Swing	$R_L = 10k\Omega$ $V_S = \pm 18V$ $V_S = \pm 22V$	$\pm 17.1$ $\pm 21.0$		V (min) V (min)
		$R_L = 600\Omega$ $V_S = \pm 20V$ $V_S = \pm 22V$	$\pm 31$ $\pm 37$	$\pm 30$	mA (min) mA (min)
$I_{OUT-CC}$	Instantaneous Short Circuit Current		+53 -42		mA
$R_{OUT}$	Output Impedance	$f_{IN} = 10kHz$ Closed-Loop	0.01		$\Omega$
		Open-Loop	13		
$C_{LOAD}$	Capacitive Load Drive Overshoot	100pF	16		%
$I_S$	Total Quiescent Current	$I_{OUT} = 0mA$	5	6.5	mA (max)

**Note 1:** "Absolute Maximum Ratings" indicate limits beyond which damage to the device may occur, including inoperability and degradation of device reliability and/or performance. Functional operation of the device and/or non-degradation at the *Absolute Maximum Ratings* or other conditions beyond those indicated in the *Recommended Operating Conditions* is not implied. The *Recommended Operating Conditions* indicate conditions at which the device is functional and the device should not be operated beyond such conditions. All voltages are measured with respect to the ground pin, unless otherwise specified.

**Note 2:** The *Electrical Characteristics* tables list guaranteed specifications under the listed *Recommended Operating Conditions* except as otherwise modified or specified by the *Electrical Characteristics Conditions* and/or Notes. Typical specifications are estimations only and are not guaranteed.

**Note 3:** The maximum power dissipation must be derated at elevated temperatures and is dictated by  $T_{JMAX}$ ,  $\theta_{JA}$ , and the ambient temperature,  $T_A$ . The maximum allowable power dissipation is  $P_{DMAX} = (T_{JMAX} - T_A) / \theta_{JA}$  or the number given in *Absolute Maximum Ratings*, whichever is lower.

**Note 4:** Human body model, applicable std. JESD22-A114C.

**Note 5:** Machine model, applicable std. JESD22-A115-A.

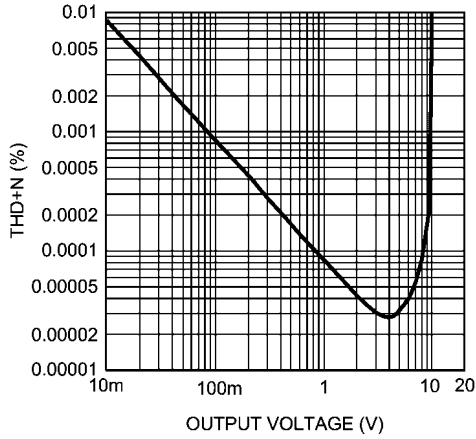
**Note 6:** Typical values represent most likely parametric norms at  $T_A = +25^\circ C$ , and at the *Recommended Operation Conditions* at the time of product characterization and are not guaranteed.

**Note 7:** Datasheet min/max specification limits are guaranteed by test or statistical analysis.

**Note 8:** PSRR is measured as follows: For  $V_S$ ,  $V_{OS}$  is measured at two supply voltages,  $\pm 7V$  and  $\pm 22V$ ,  $PSRR = |20 \log(\Delta V_{OS} / \Delta V_S)|$ .

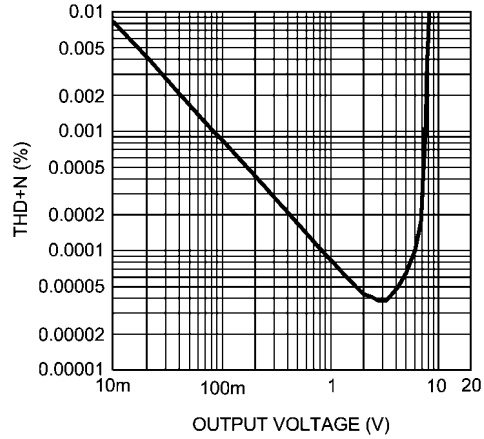
# Typical Performance Characteristics

**THD+N vs Output Voltage**  
 $V_{CC} = 15V, V_{EE} = -15V$   
 $R_L = 2k\Omega$



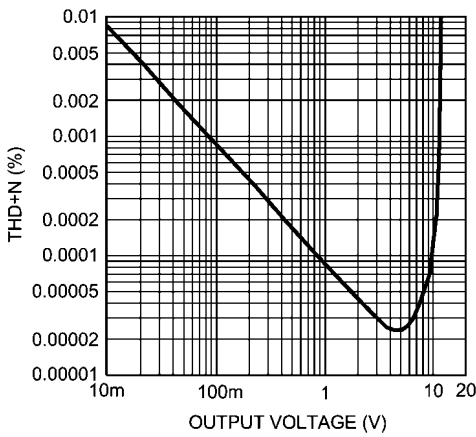
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**THD+N vs Output Voltage**  
 $V_{CC} = 12V, V_{EE} = -12V$   
 $R_L = 2k\Omega$



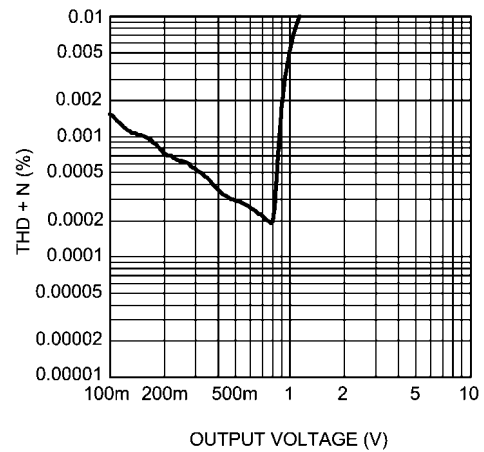
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**THD+N vs Output Voltage**  
 $V_{CC} = 22V, V_{EE} = -22V$   
 $R_L = 2k\Omega$



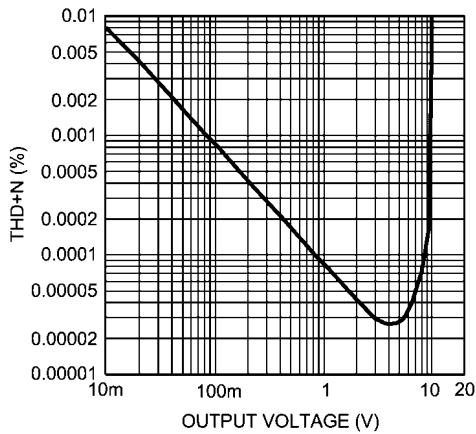
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**THD+N vs Output Voltage**  
 $V_{CC} = 2.5V, V_{EE} = -2.5V$   
 $R_L = 2k\Omega$



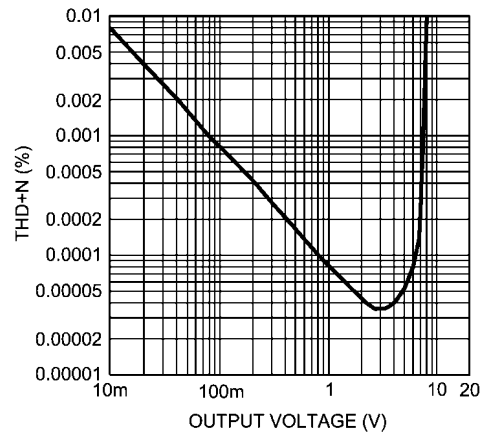
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**THD+N vs Output Voltage**  
 $V_{CC} = 15V, V_{EE} = -15V$   
 $R_L = 600\Omega$



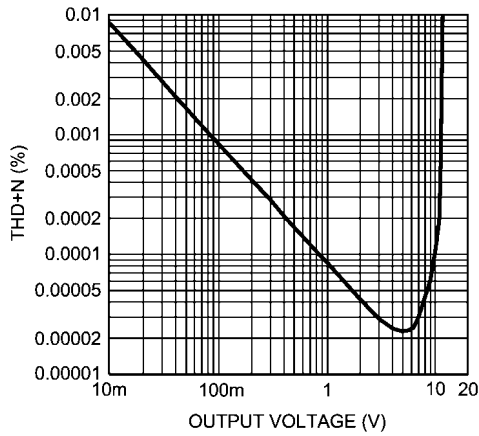
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**THD+N vs Output Voltage**  
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 $R_L = 600\Omega$



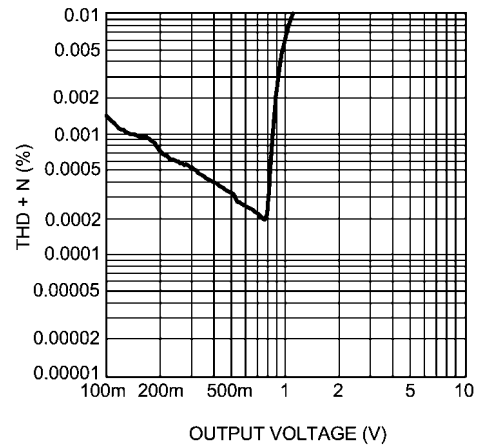
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**THD+N vs Output Voltage**  
 $V_{CC} = 22V, V_{EE} = -22V$   
 $R_L = 600\Omega$



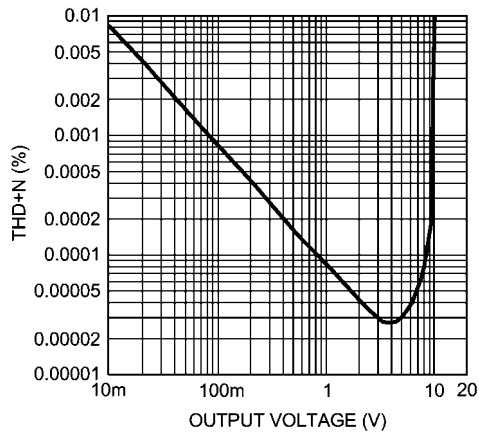
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**THD+N vs Output Voltage**  
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 $R_L = 600\Omega$



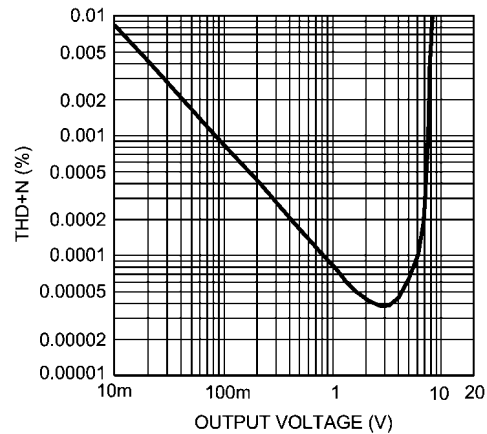
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**THD+N vs Output Voltage**  
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 $R_L = 10k\Omega$



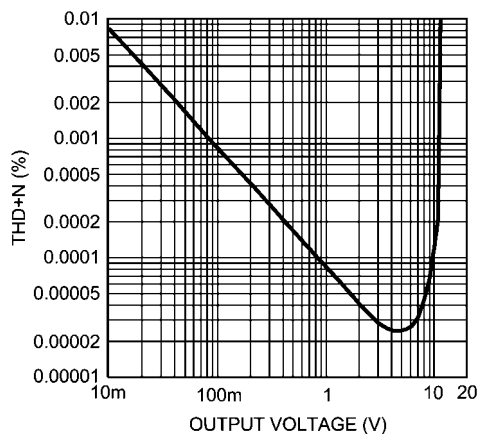
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**THD+N vs Output Voltage**  
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 $R_L = 10k\Omega$



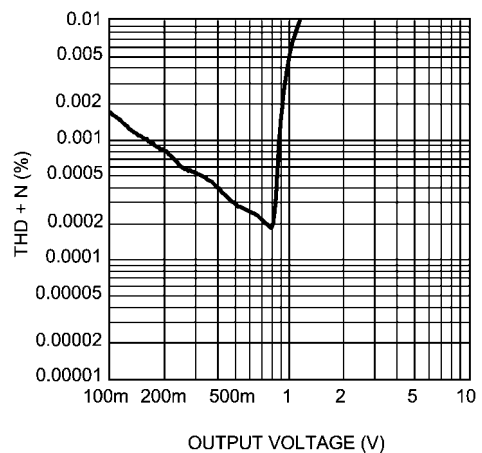
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**THD+N vs Output Voltage**  
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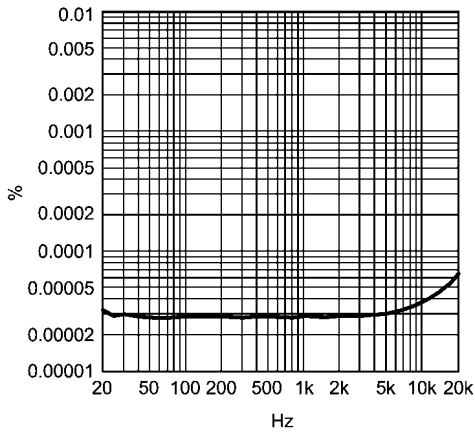
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**THD+N vs Output Voltage**  
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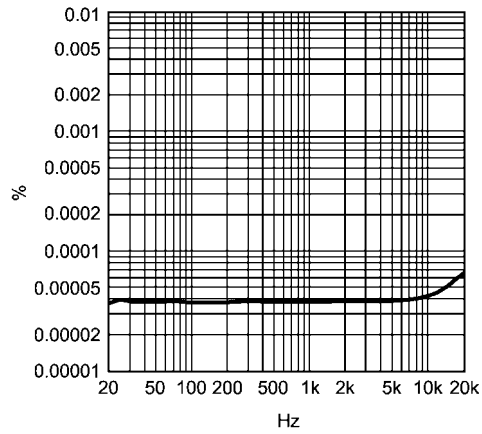
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**THD+N vs Frequency**  
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 $R_L = 2k\Omega$



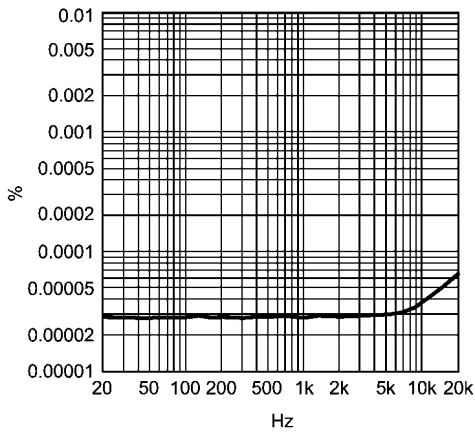
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**THD+N vs Frequency**  
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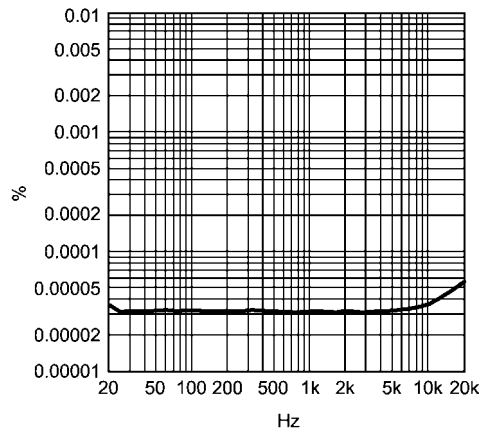
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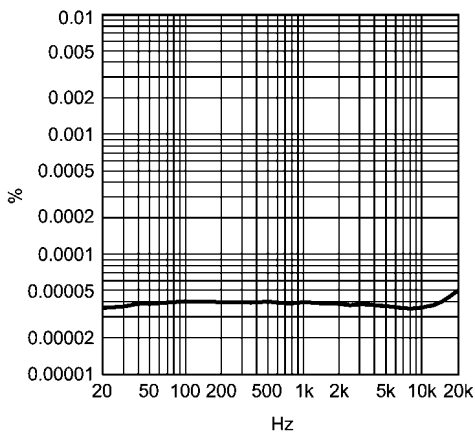
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**THD+N vs Frequency**  
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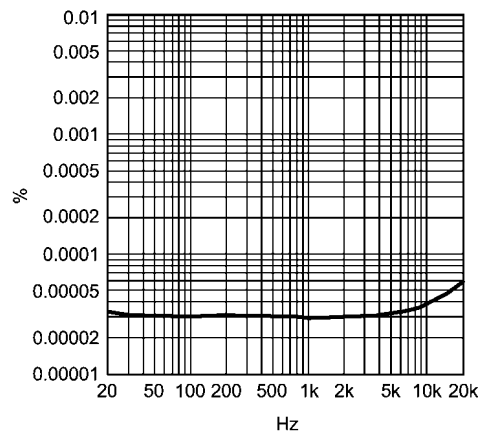
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**THD+N vs Frequency**  
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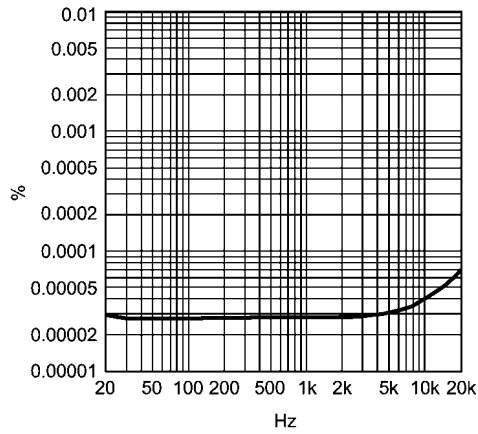
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**THD+N vs Frequency**  
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 $R_L = 600\Omega$



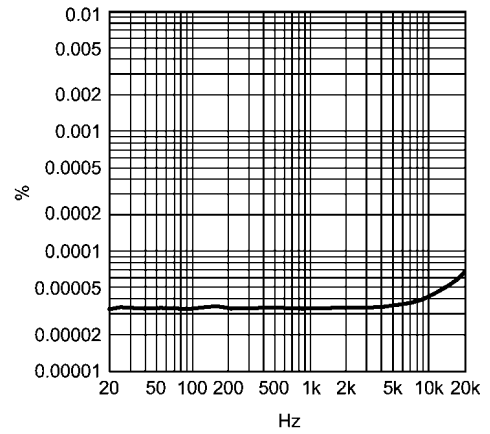
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**THD+N vs Frequency**  
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 $R_L = 10k\Omega$



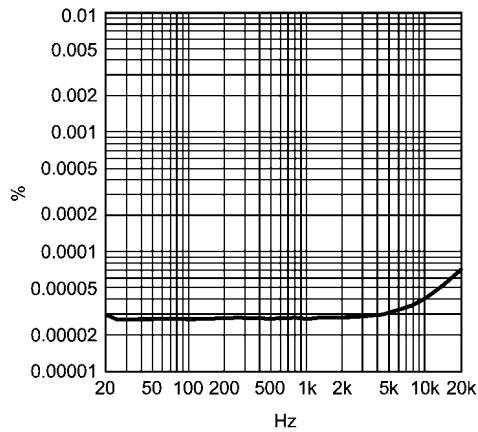
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**THD+N vs Frequency**  
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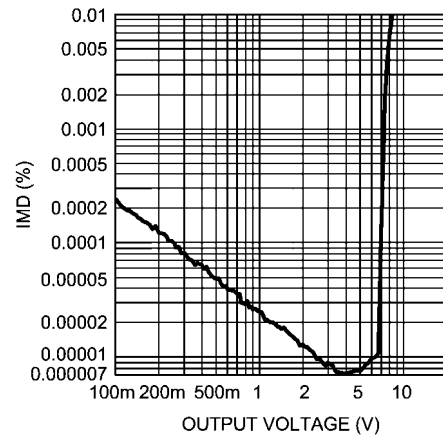
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**THD+N vs Frequency**  
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 $R_L = 10k\Omega$



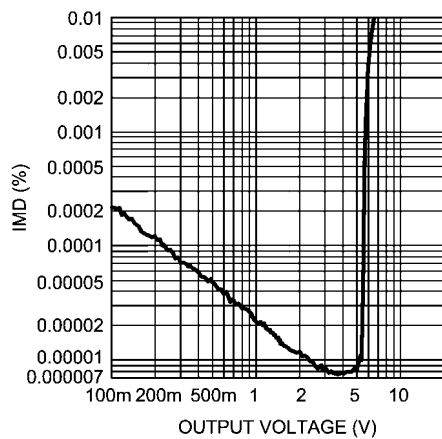
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**IMD vs Output Voltage**  
 $V_{CC} = 15V, V_{EE} = -15V$   
 $R_L = 2k\Omega$



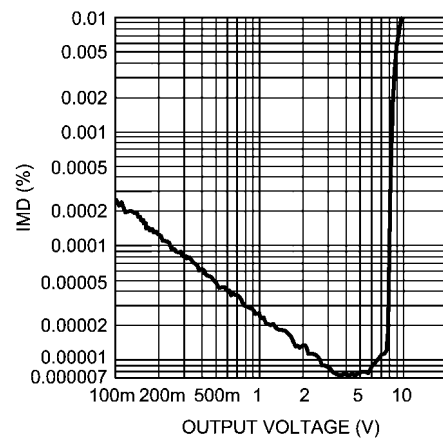
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**IMD vs Output Voltage**  
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 $R_L = 2k\Omega$



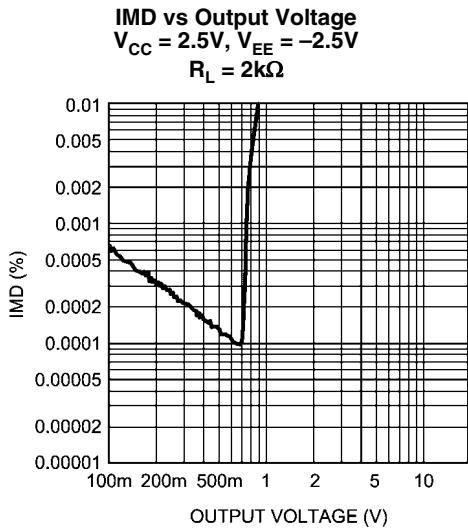
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**IMD vs Output Voltage**  
 $V_{CC} = 22V, V_{EE} = -22V$   
 $R_L = 2k\Omega$

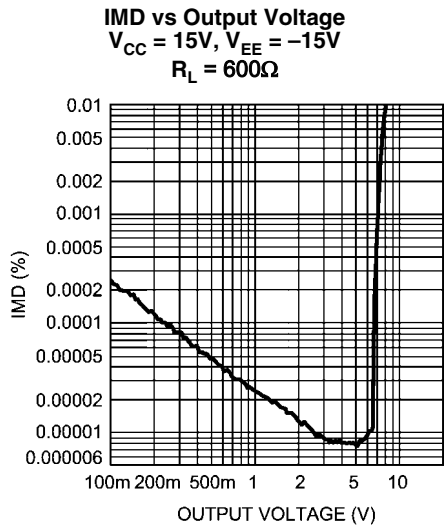


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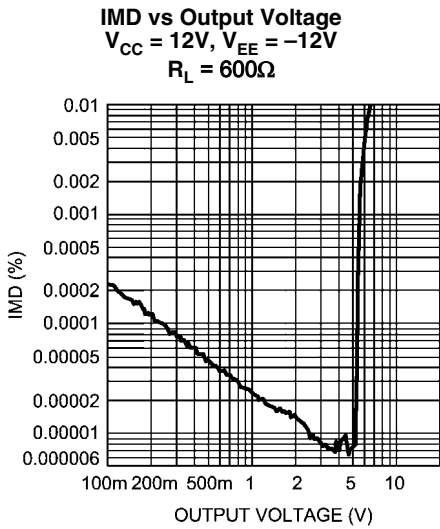




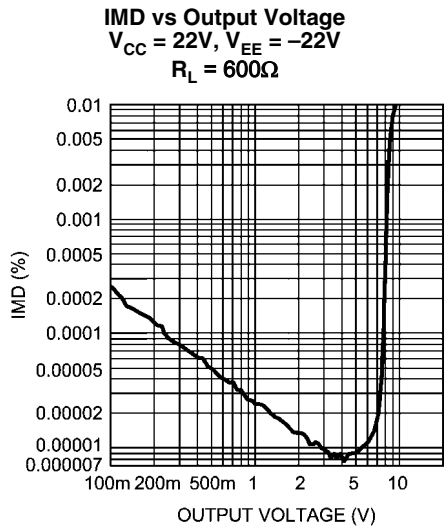
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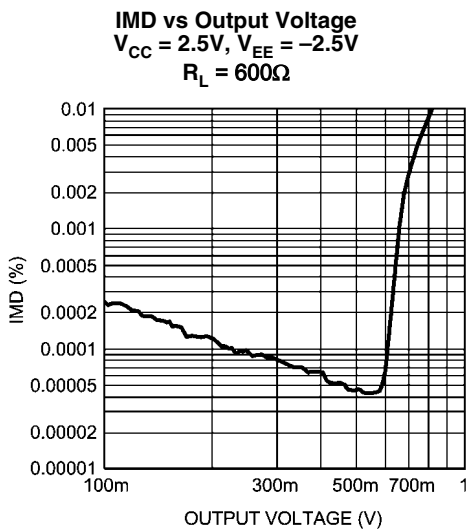
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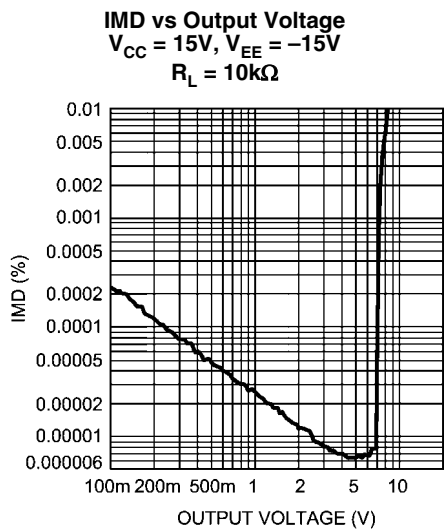
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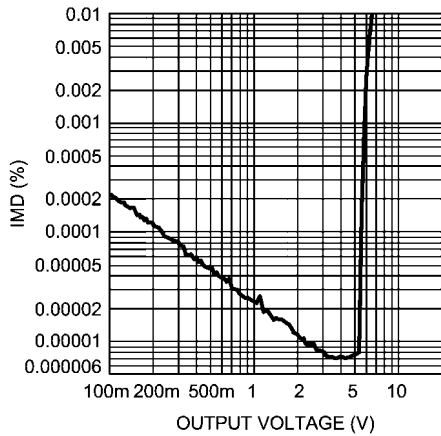


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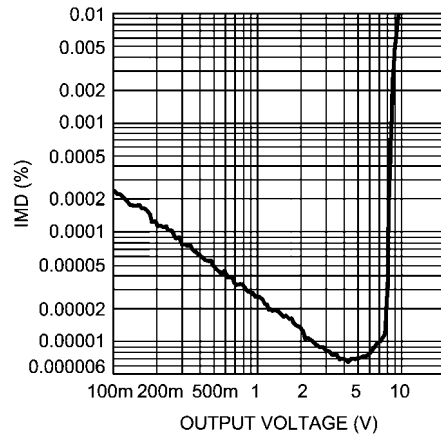
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**IMD vs Output Voltage**  
 $V_{CC} = 12V, V_{EE} = -12V$   
 $R_L = 10k\Omega$



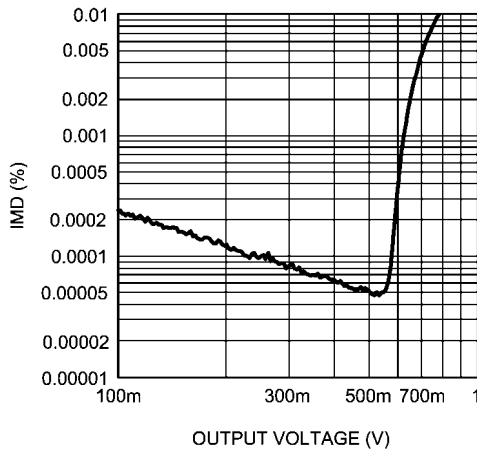
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**IMD vs Output Voltage**  
 $V_{CC} = 22V, V_{EE} = -22V$   
 $R_L = 10k\Omega$



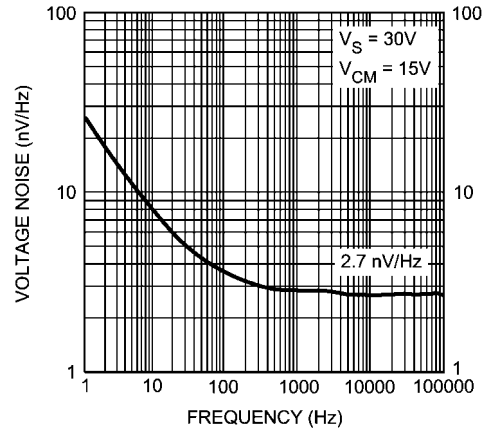
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**IMD vs Output Voltage**  
 $V_{CC} = 2.5V, V_{EE} = -2.5V$   
 $R_L = 10k\Omega$



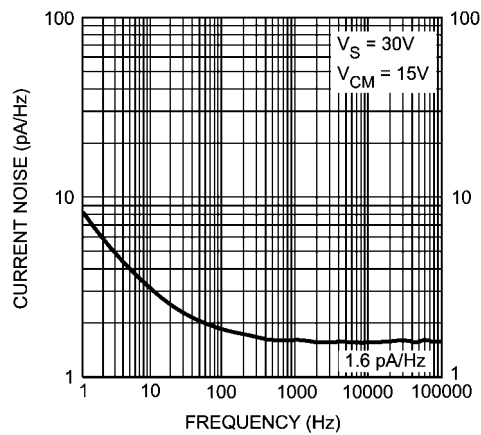
300194f6

**Voltage Noise Density vs Frequency**



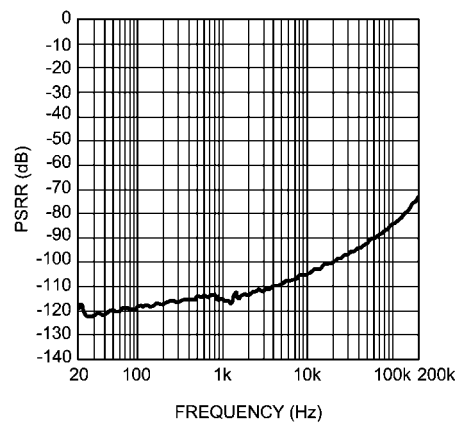
300194h6

**Current Noise Density vs Frequency**

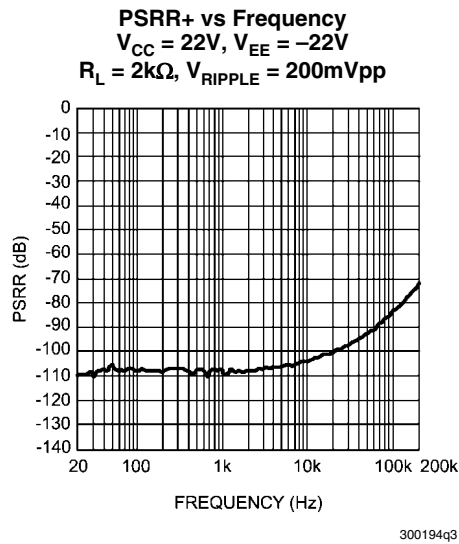
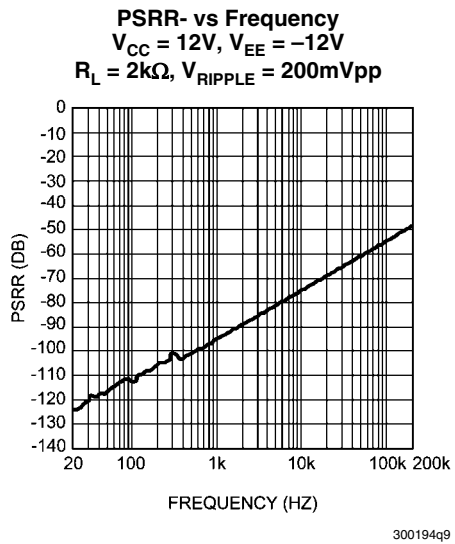
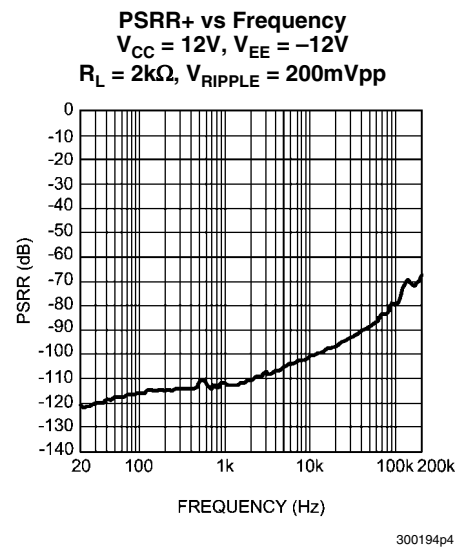
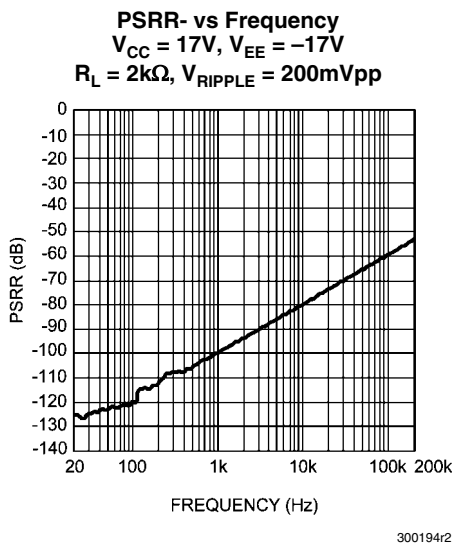
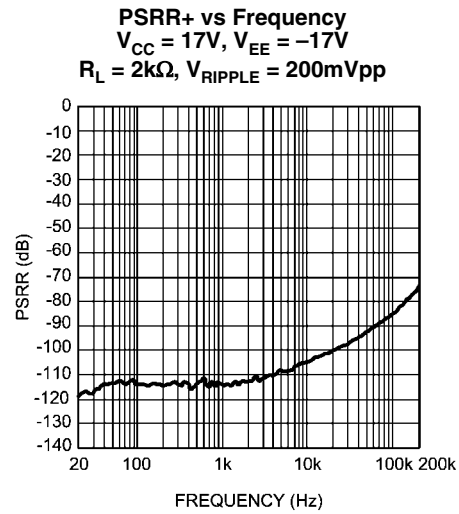
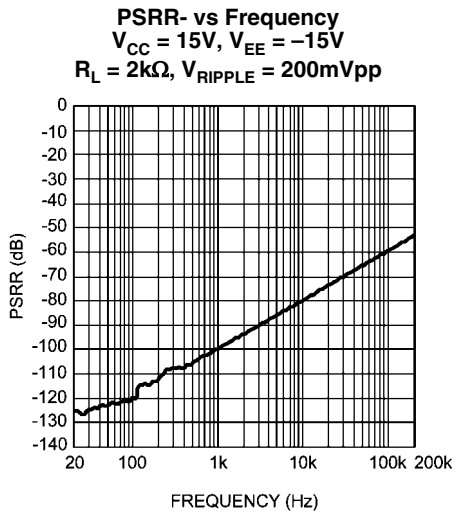


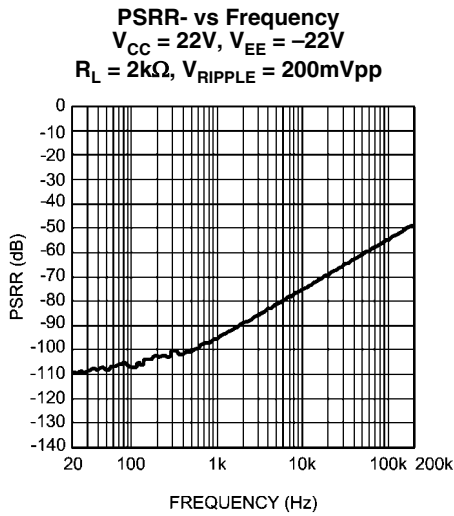
300194h7

**PSRR+ vs Frequency**  
 $V_{CC} = 15V, V_{EE} = -15V$   
 $R_L = 2k\Omega, V_{RIPPLE} = 200mVpp$

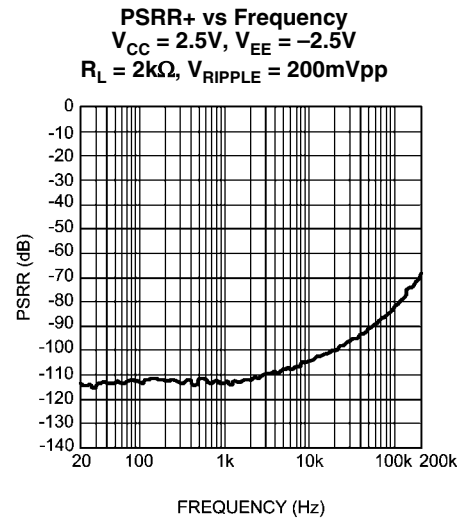


300194p7

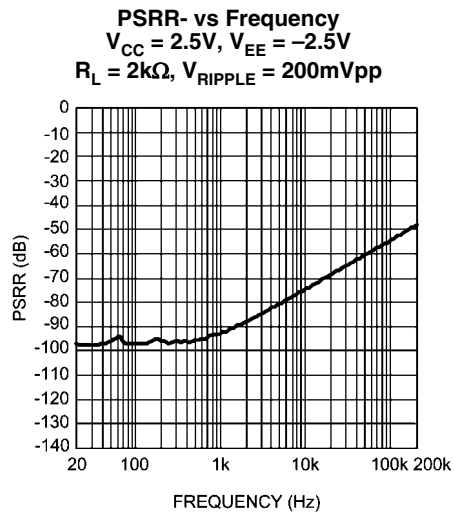




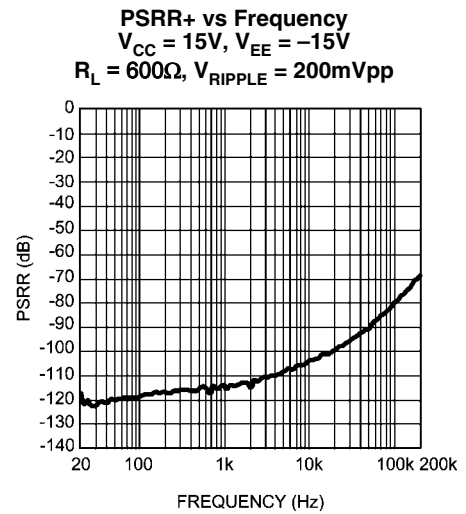
300194r8



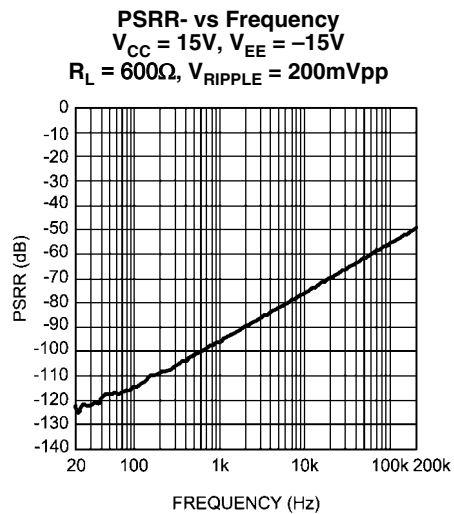
300194p1



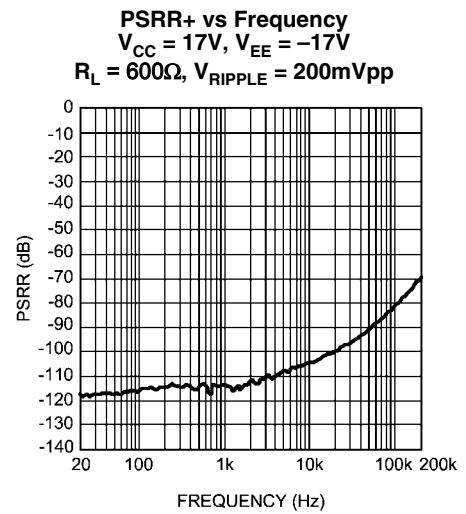
300194q6



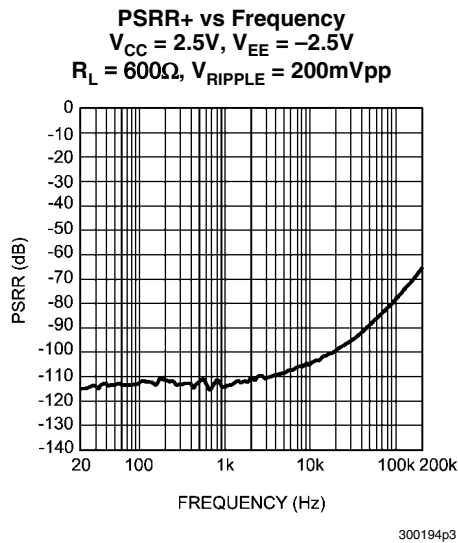
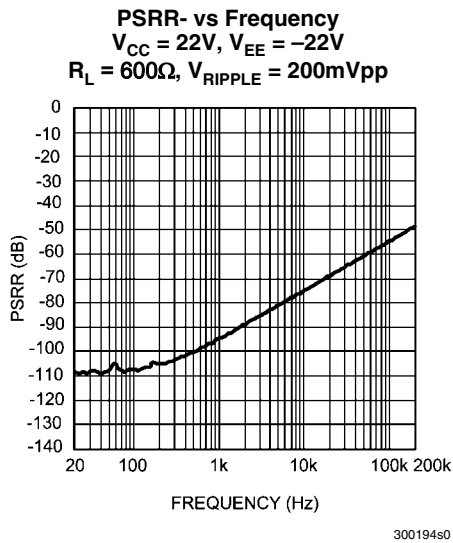
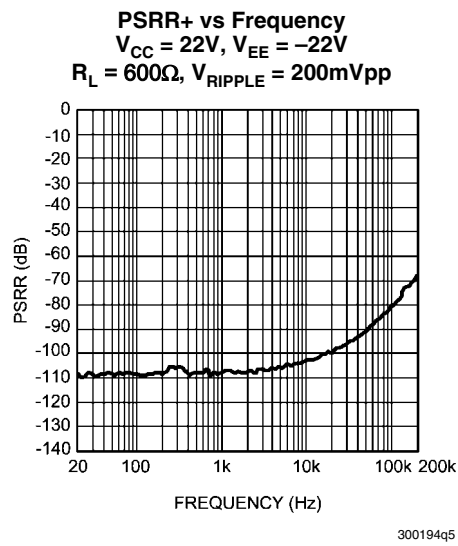
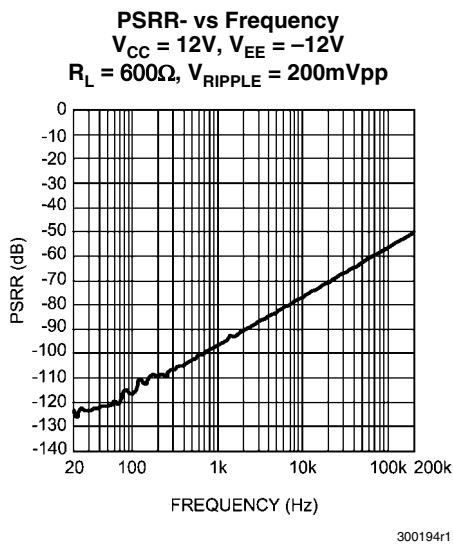
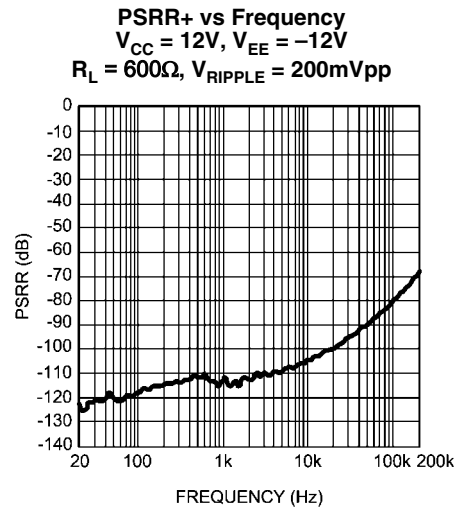
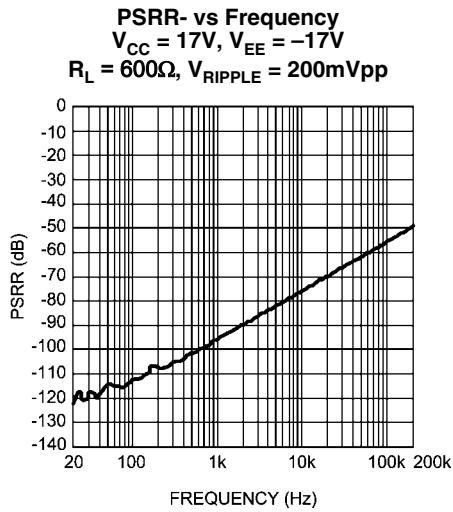
300194p9

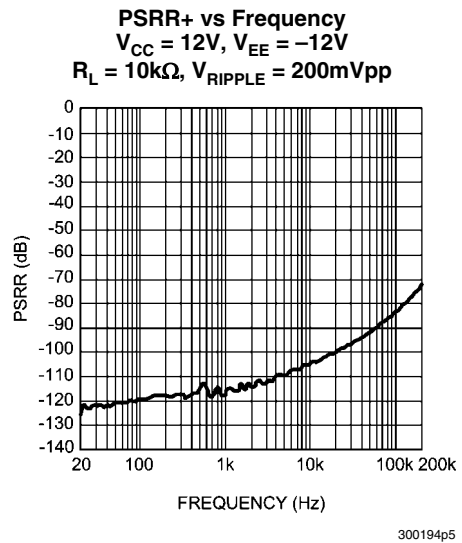
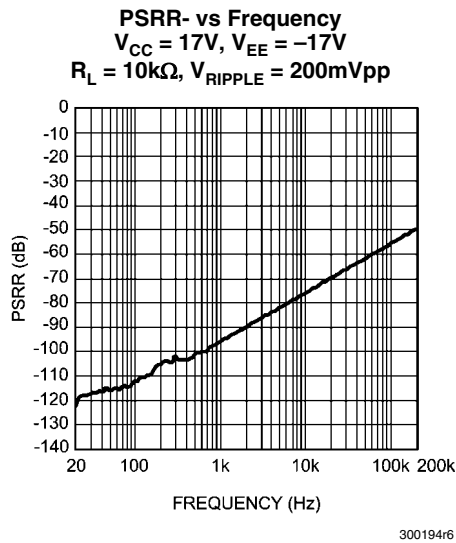
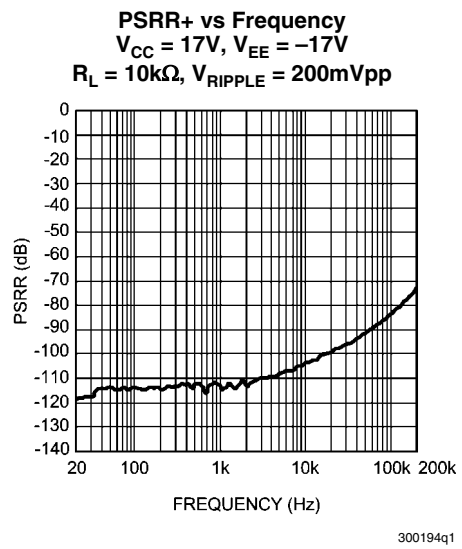
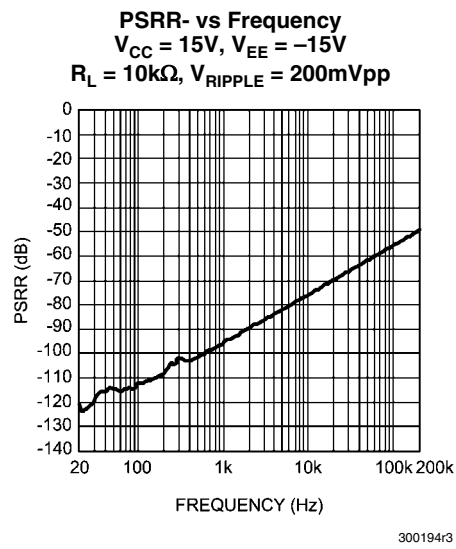
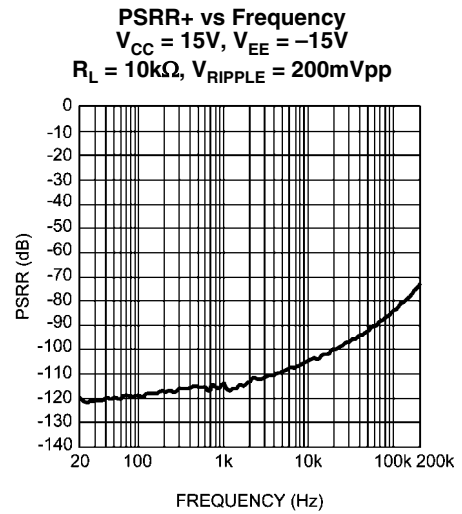
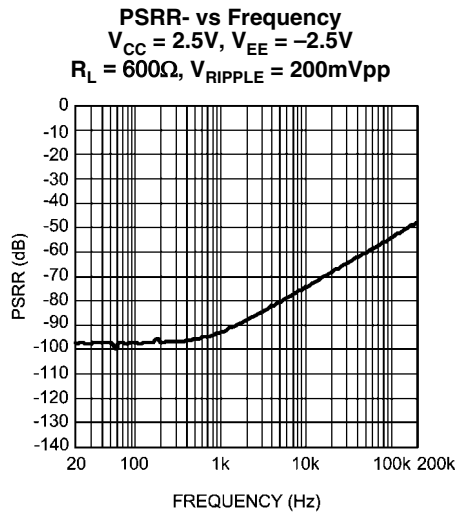


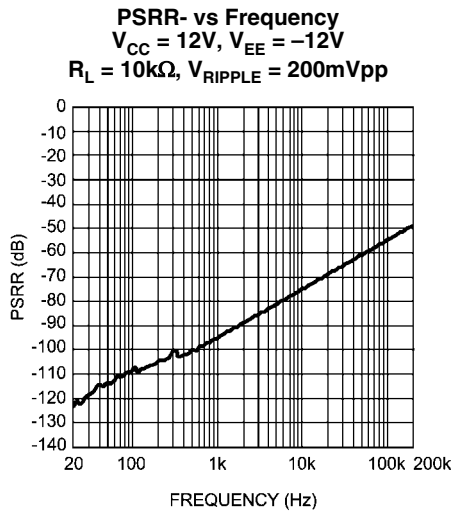
300194r4



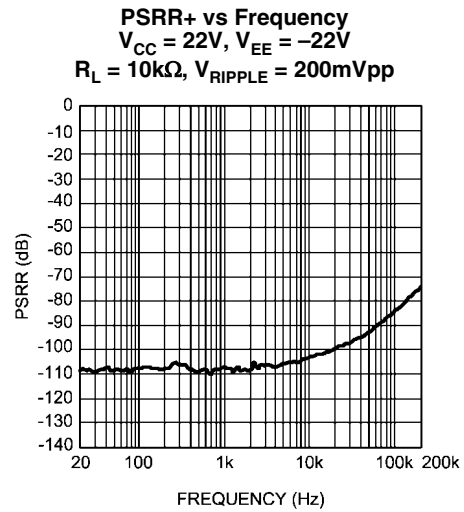
300194q2



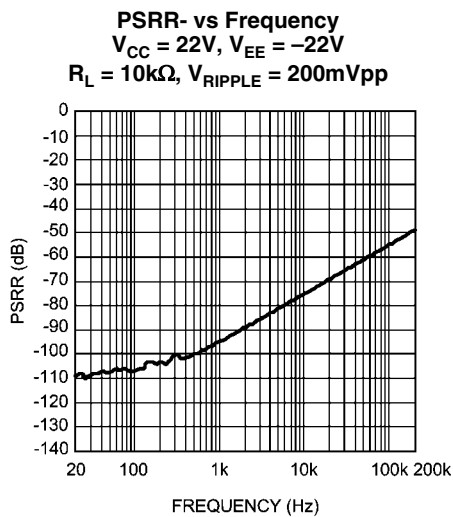




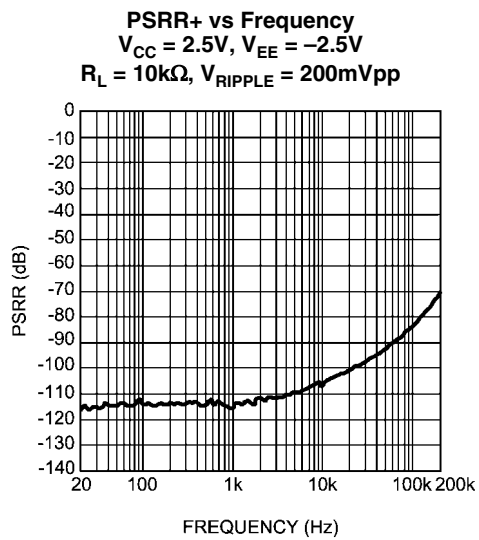
300194r0



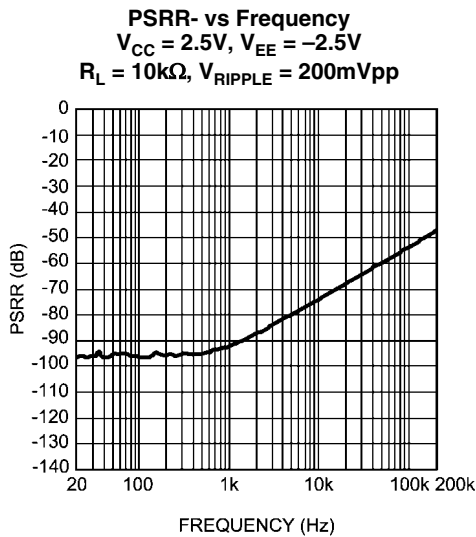
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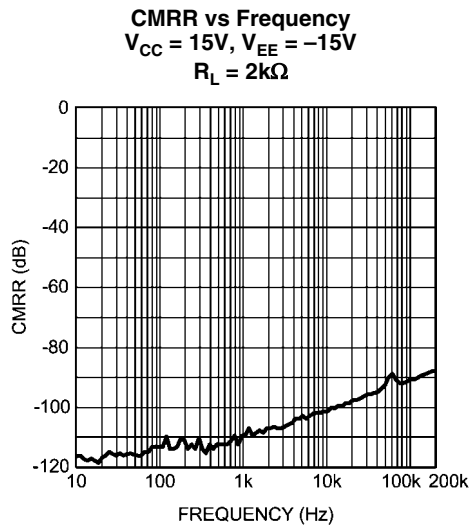
300194r9



300194p2

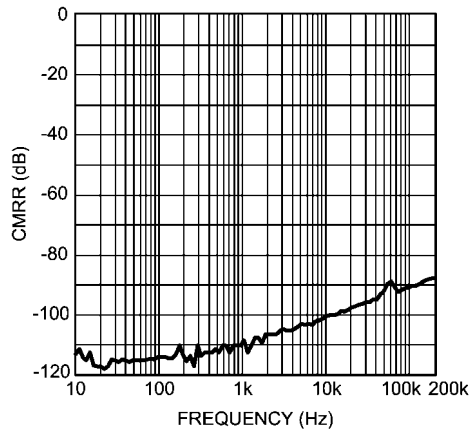


300194q7



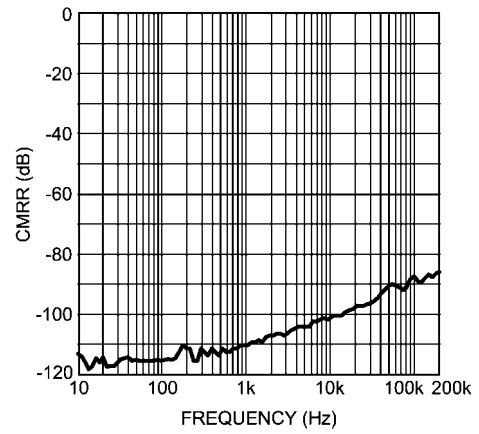
300194g0

**CMRR vs Frequency**  
 $V_{CC} = 12V, V_{EE} = -12V$   
 $R_L = 2k\Omega$



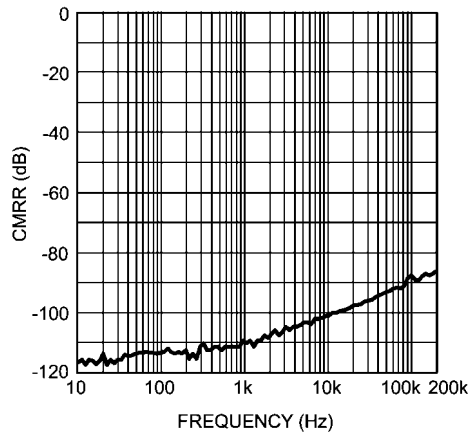
300194f7

**CMRR vs Frequency**  
 $V_{CC} = 22V, V_{EE} = -22V$   
 $R_L = 2k\Omega$



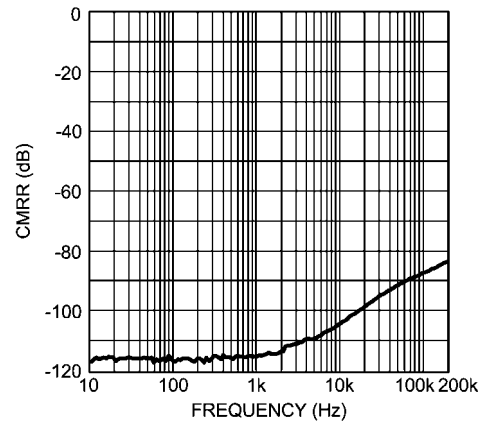
300194g3

**CMRR vs Frequency**  
 $V_{CC} = 2.5V, V_{EE} = -2.5V$   
 $R_L = 2k\Omega$



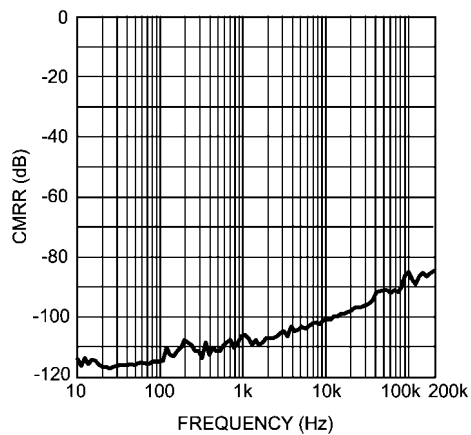
300194f4

**CMRR vs Frequency**  
 $V_{CC} = 15V, V_{EE} = -15V$   
 $R_L = 600\Omega$



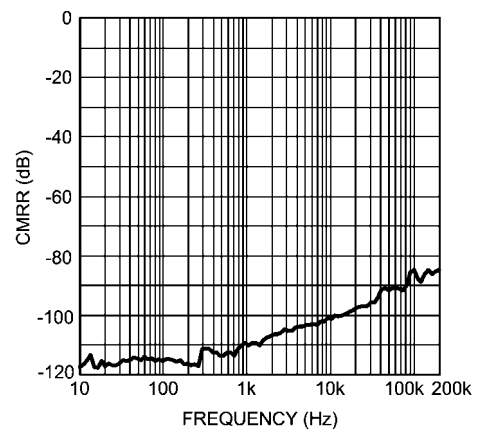
300194o9

**CMRR vs Frequency**  
 $V_{CC} = 12V, V_{EE} = -12V$   
 $R_L = 600\Omega$



300194f9

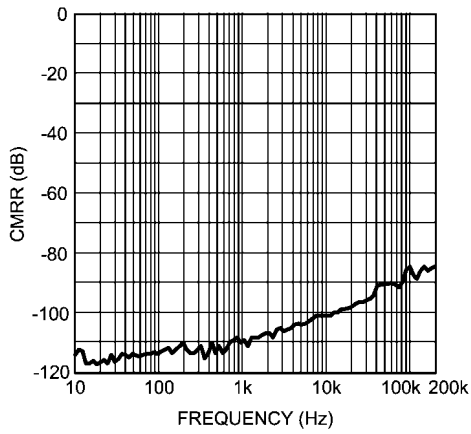
**CMRR vs Frequency**  
 $V_{CC} = 22V, V_{EE} = -22V$   
 $R_L = 600\Omega$



300194g5

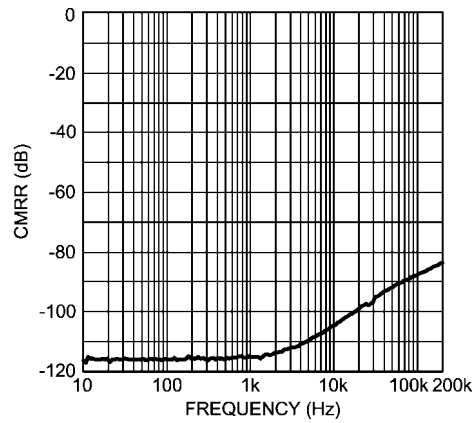


**CMRR vs Frequency**  
 $V_{CC} = 2.5V, V_{EE} = -2.5V$   
 $R_L = 600\Omega$



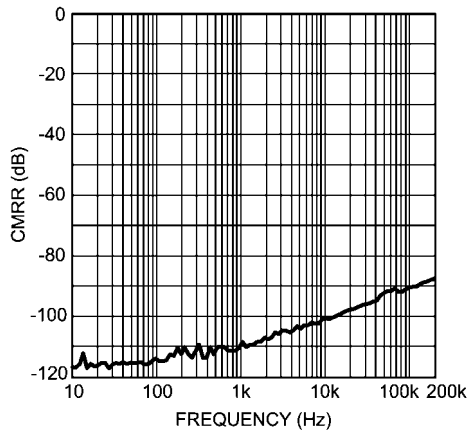
300194f6

**CMRR vs Frequency**  
 $V_{CC} = 15V, V_{EE} = -15V$   
 $R_L = 10k\Omega$



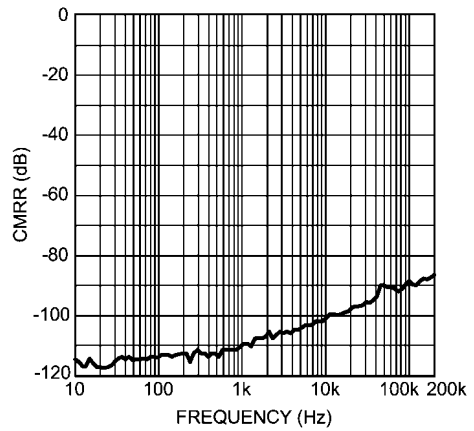
300194o8

**CMRR vs Frequency**  
 $V_{CC} = 12V, V_{EE} = -12V$   
 $R_L = 10k\Omega$



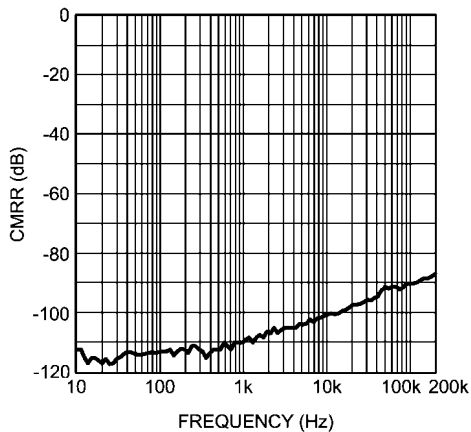
300194f8

**CMRR vs Frequency**  
 $V_{CC} = 22V, V_{EE} = -22V$   
 $R_L = 10k\Omega$



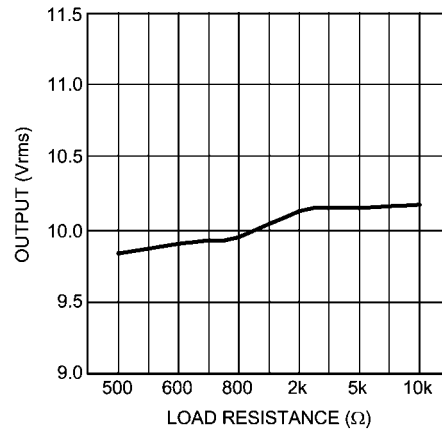
300194g4

**CMRR vs Frequency**  
 $V_{CC} = 2.5V, V_{EE} = -2.5V$   
 $R_L = 10k\Omega$



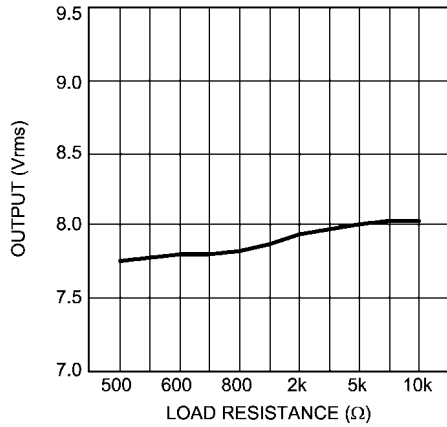
300194f5

**Output Voltage vs Load Resistance**  
 $V_{CC} = 15V, V_{EE} = -15V$   
 $THD+N = 1\%$



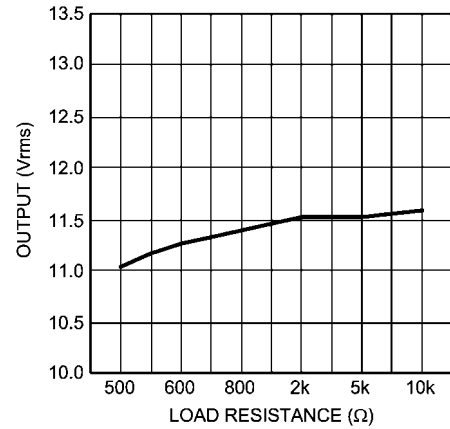
300194h1

**Output Voltage vs Load Resistance**  
 $V_{CC} = 12V, V_{EE} = -12V$   
 THD+N = 1%



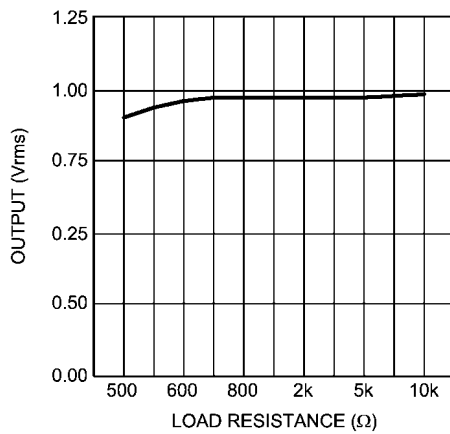
300194h0

**Output Voltage vs Load Resistance**  
 $V_{CC} = 22V, V_{EE} = -22V$   
 THD+N = 1%



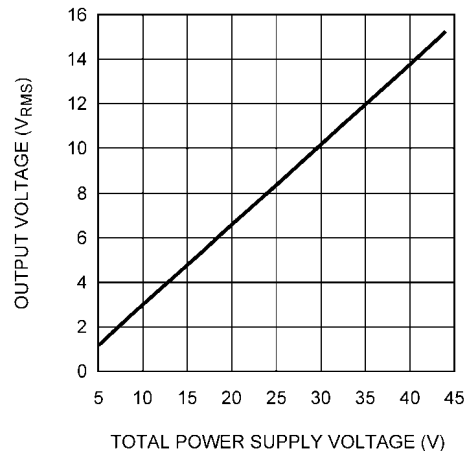
300194h2

**Output Voltage vs Load Resistance**  
 $V_{CC} = 2.5V, V_{EE} = -2.5V$   
 THD+N = 1%



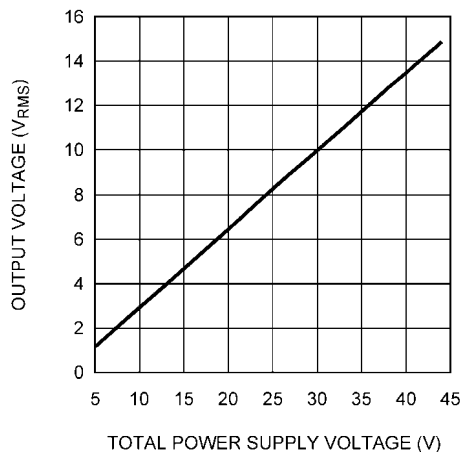
300194g9

**Output Voltage vs Total Power Supply Voltage**  
 $R_L = 2k\Omega, THD+N = 1\%$



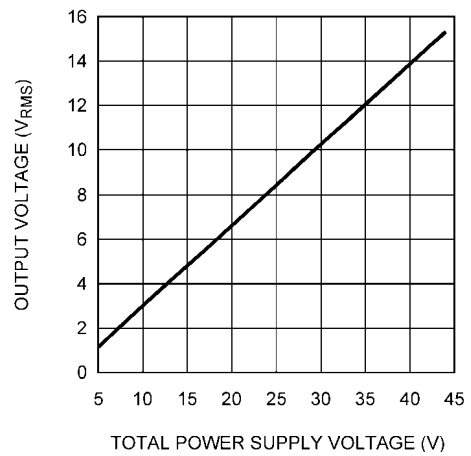
30019407

**Output Voltage vs Total Power Supply Voltage**  
 $R_L = 600\Omega, THD+N = 1\%$



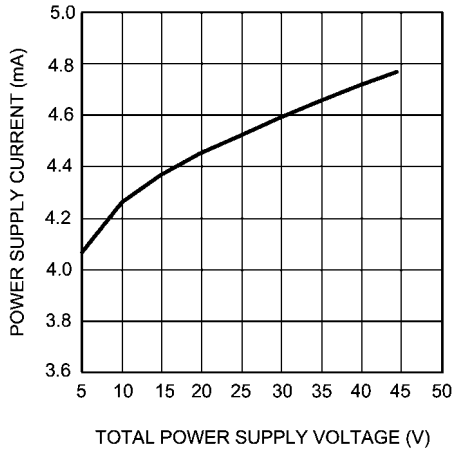
30019409

**Output Voltage vs Total Power Supply Voltage**  
 $R_L = 10k\Omega, THD+N = 1\%$



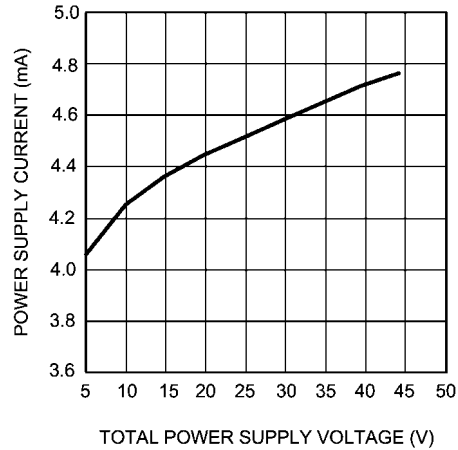
30019408

**Power Supply Current vs Total Power Supply Voltage**  
 $R_L = 2k\Omega$



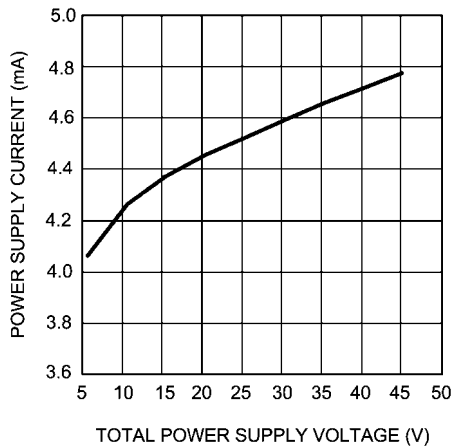
30019413

**Power Supply Current vs Total Power Supply Voltage**  
 $R_L = 600\Omega$



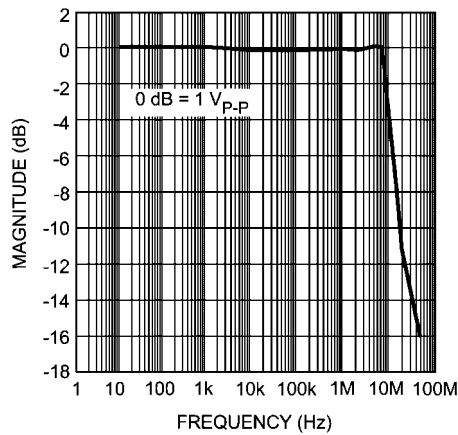
30019415

**Power Supply Current vs Total Power Supply Voltage**  
 $R_L = 10k\Omega$



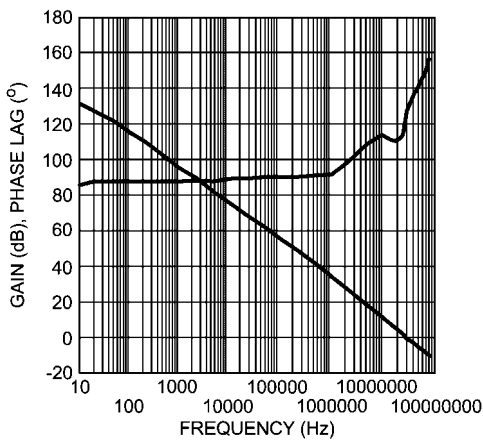
30019414

**Full Power Bandwidth vs Frequency**  
 $V_S = \pm 18V, R_L = 2k\Omega$



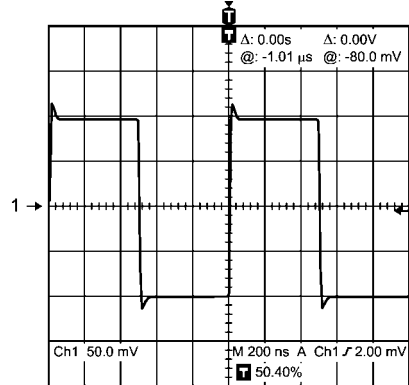
300194j0

**Gain Phase vs Frequency**  
 $V_S = \pm 18V, R_L = 2k\Omega$



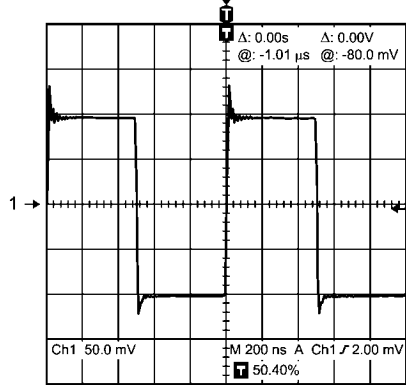
300194j1

**Small-Signal Transient Response**  
 $A_V = 1, C_L = 10pF$



3001947

### Small-Signal Transient Response $A_V = 1, C_L = 100\text{pF}$



300194i8

## Application Information

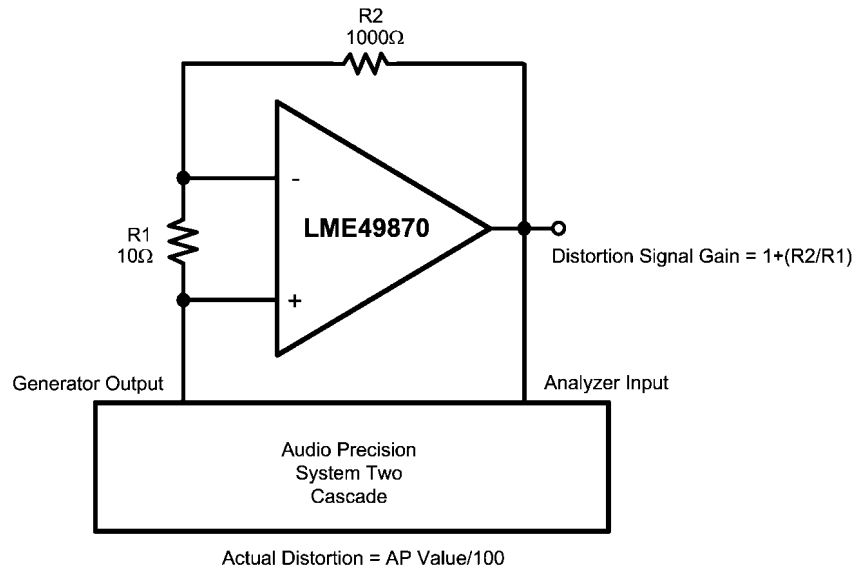
### DISTORTION MEASUREMENTS

The vanishingly low residual distortion produced by LME49870 is below the capabilities of all commercially available equipment. This makes distortion measurements just slightly more difficult than simply connecting a distortion meter to the amplifier's inputs and outputs. The solution, however, is quite simple: an additional resistor. Adding this resistor extends the resolution of the distortion measurement equipment.

The LME49870's low residual distortion is an input referred internal error. As shown in Figure 1, adding the 10Ω resistor connected between the amplifier's inverting and non-inverting

inputs changes the amplifier's noise gain. The result is that the error signal (distortion) is amplified by a factor of 101. Although the amplifier's closed-loop gain is unaltered, the feedback available to correct distortion errors is reduced by 101, which means that measurement resolution increases by 101. To ensure minimum effects on distortion measurements, keep the value of R1 low as shown in Figure 1.

This technique is verified by duplicating the measurements with high closed loop gain and/or making the measurements at high frequencies. Doing so produces distortion components that are within the measurement equipment's capabilities. This datasheet's THD+N and IMD values were generated using the above described circuit connected to an Audio Precision System Two Cascade.



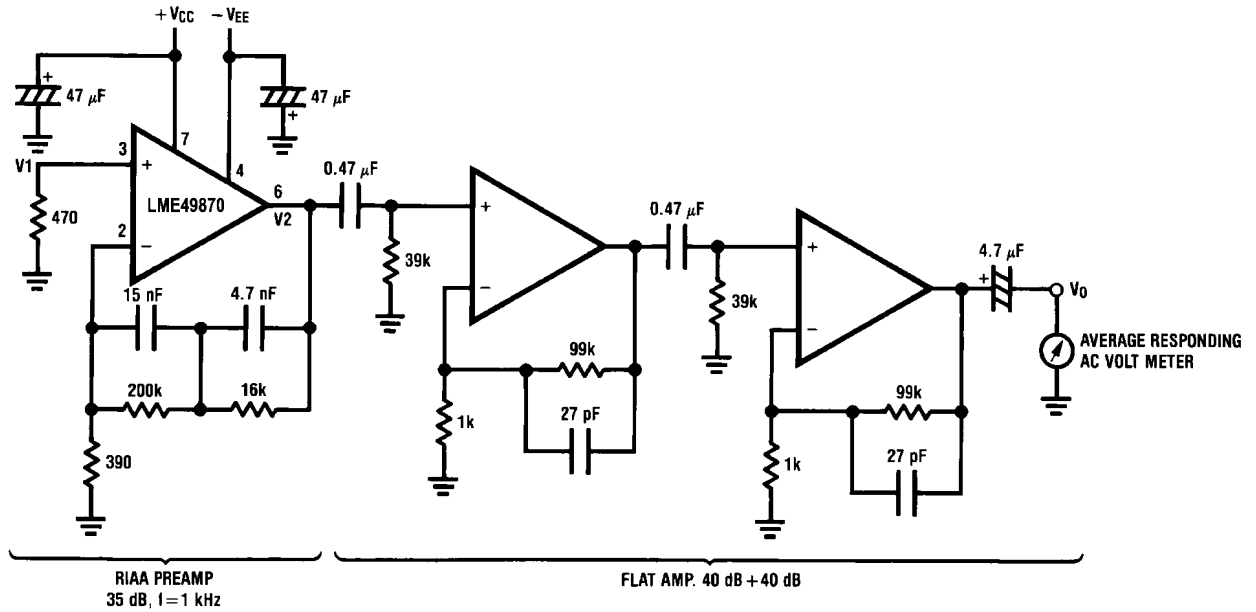
300194k4

**FIGURE 1. THD+N and IMD Distortion Test Circuit**

The LME49870 is a high speed op amp with excellent phase margin and stability. Capacitive loads up to 100pF will cause little change in the phase characteristics of the amplifiers and are therefore allowable.

Capacitive loads greater than 100pF must be isolated from the output. The most straightforward way to do this is to put

a resistor in series with the output. This resistor will also prevent excess power dissipation if the output is accidentally shorted.

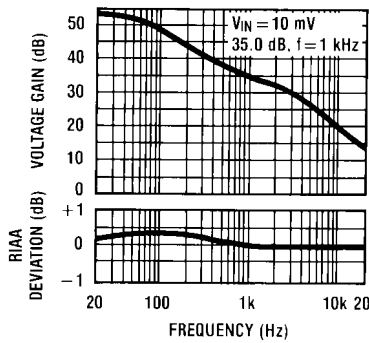


30019427

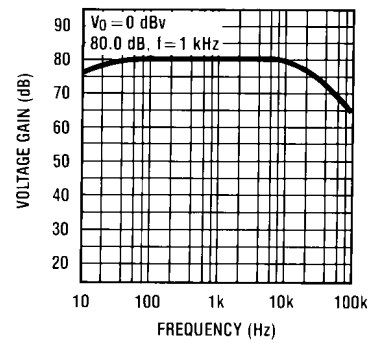
Complete shielding is required to prevent induced pick up from external sources. Always check with oscilloscope for power line noise.

**Noise Measurement Circuit**  
**Total Gain: 115 dB @  $f = 1$  kHz**  
**Input Referred Noise Voltage:  $e_n = V_0/560,000$  (V)**

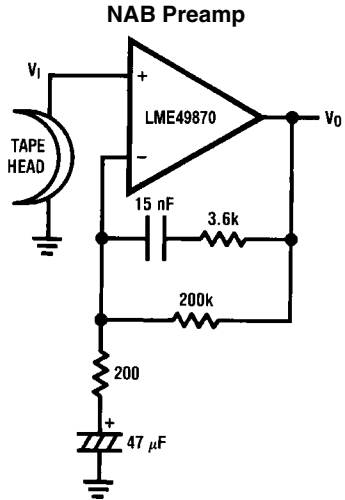
**RIAA Preamp Voltage Gain, RIAA Deviation vs Frequency**



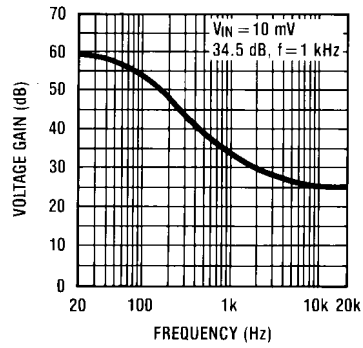
**Flat Amp Voltage Gain vs Frequency**



TYPICAL APPLICATIONS



NAB Preamp Voltage Gain vs Frequency

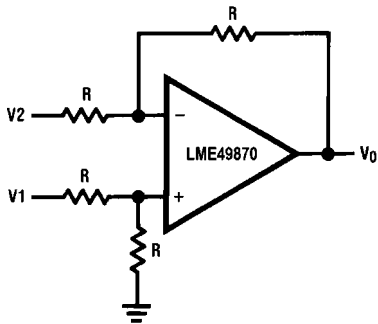


30019431

$A_v = 34.5$   
 $F = 1 \text{ kHz}$   
 $E_n = 0.38 \mu\text{V}$   
 A Weighted

30019430

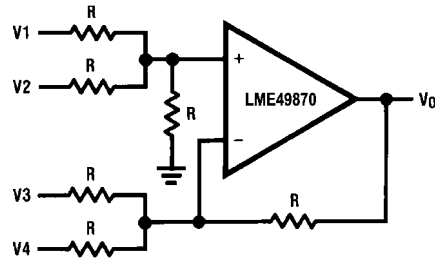
Balanced to Single Ended Converter



$V_o = V1 - V2$

30019432

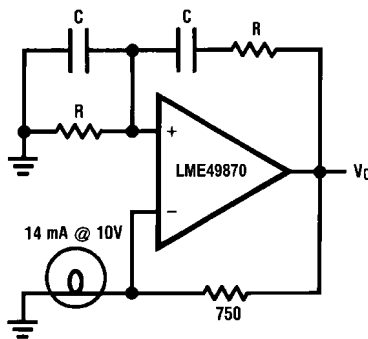
Adder/Subtractor



$V_o = V1 + V2 - V3 - V4$

30019433

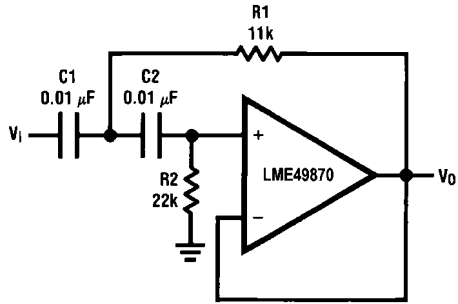
Sine Wave Oscillator



30019434

$f_o = \frac{1}{2\pi RC}$

**Second Order High Pass Filter (Butterworth)**



30019435

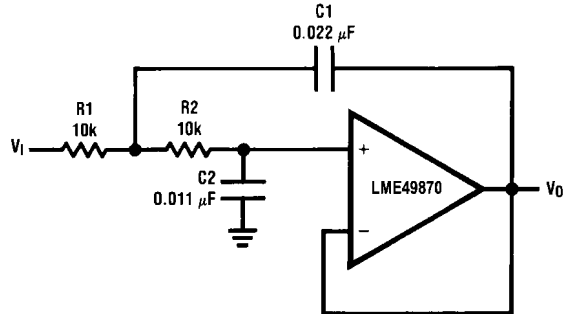
if  $C1 = C2 = C$

$$R1 = \frac{\sqrt{2}}{2\omega_0 C}$$

$$R2 = 2 \cdot R1$$

Illustration is  $f_0 = 1 \text{ kHz}$

**Second Order Low Pass Filter (Butterworth)**



30019436

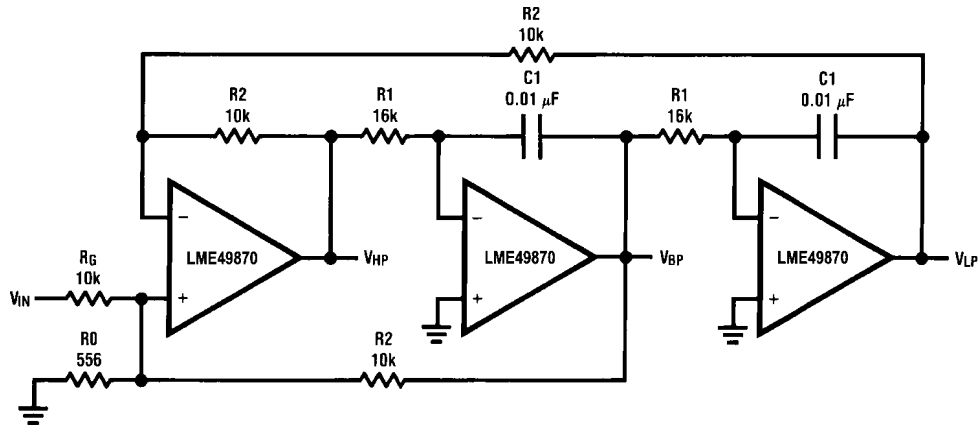
if  $R1 = R2 = R$

$$C1 = \frac{\sqrt{2}}{\omega_0 R}$$

$$C2 = \frac{C1}{2}$$

Illustration is  $f_0 = 1 \text{ kHz}$

**State Variable Filter**



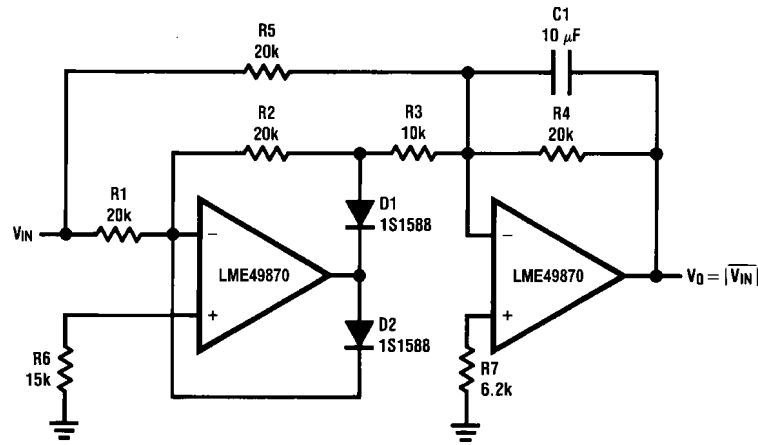
30019437

$$f_0 = \frac{1}{2\pi C1 R1}, Q = \frac{1}{2} \left( 1 + \frac{R2}{R0} + \frac{R2}{RG} \right), A_{BP} = Q A_{LP} = Q A_{LH} = \frac{R2}{RG}$$

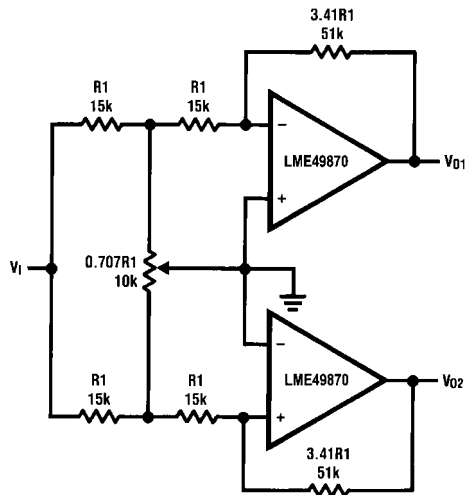
Illustration is  $f_0 = 1 \text{ kHz}, Q = 10, A_{BP} = 1$



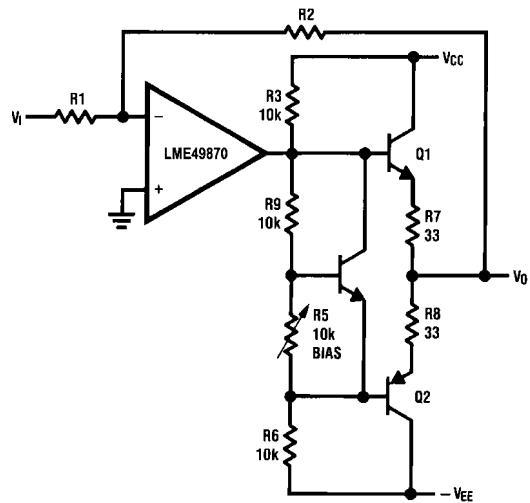
AC/DC Converter



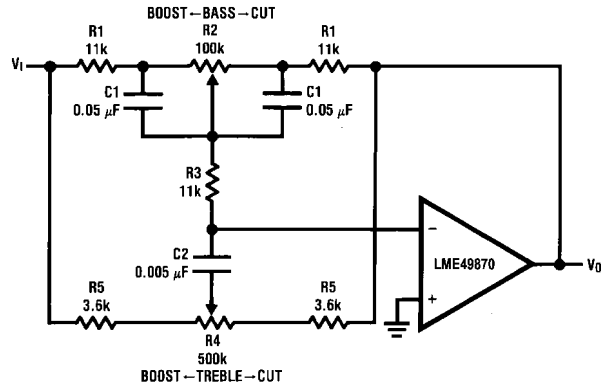
2 Channel Panning Circuit (Pan Pot)



Line Driver



Tone Control



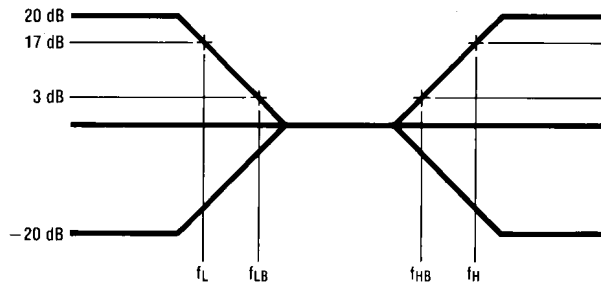
30019441

$$f_L = \frac{1}{2\pi R_2 C_1}, f_{LB} = \frac{1}{2\pi R_1 C_1}$$

$$f_H = \frac{1}{2\pi R_5 C_2}, f_{HB} = \frac{1}{2\pi(R_1 + R_5 + 2R_3)C_2}$$

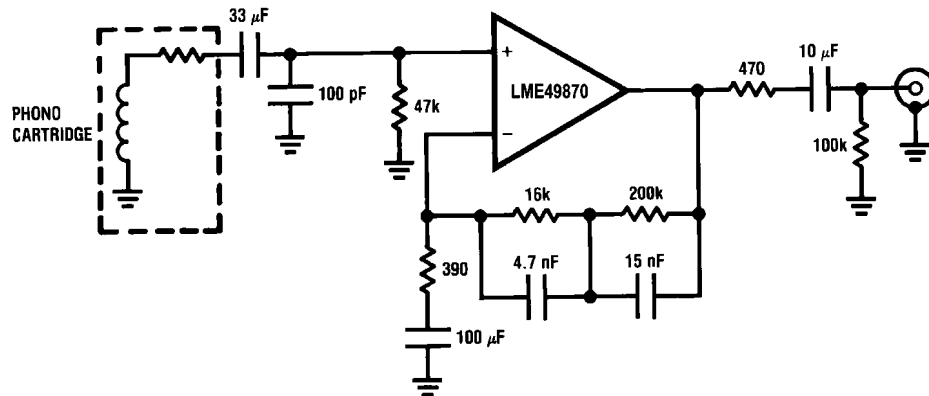
Illustration is:

$f_L = 32 \text{ Hz}$ ,  $f_{LB} = 320 \text{ Hz}$   
 $f_H = 11 \text{ kHz}$ ,  $f_{HB} = 1.1 \text{ kHz}$



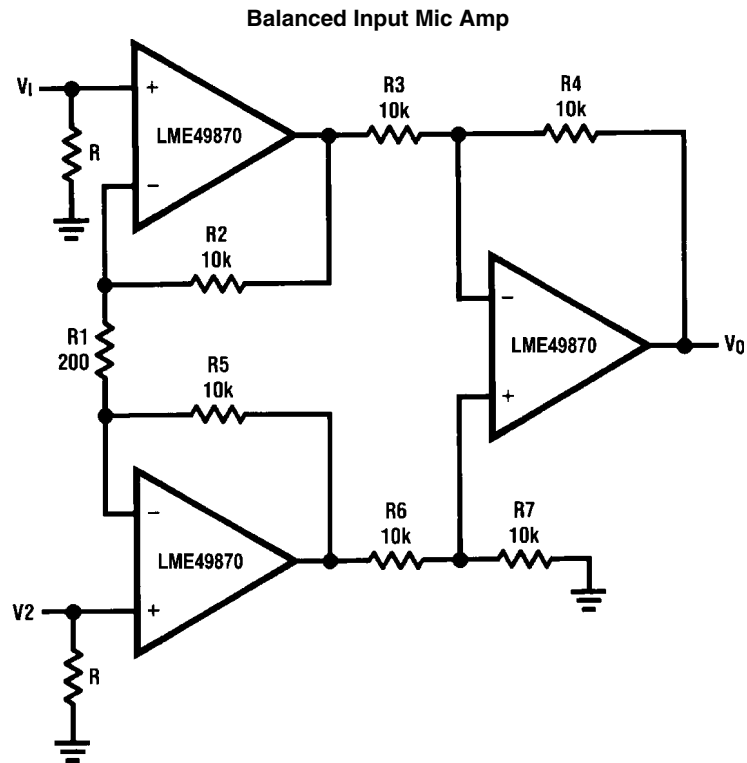
30019442

RIAA Preamp



30019403

$A_v = 35 \text{ dB}$   
 $E_n = 0.33 \mu\text{V}$   
 $S/N = 90 \text{ dB}$   
 $f = 1 \text{ kHz}$   
 A Weighted  
 A Weighted,  $V_{IN} = 10 \text{ mV}$   
 @  $f = 1 \text{ kHz}$



30019443

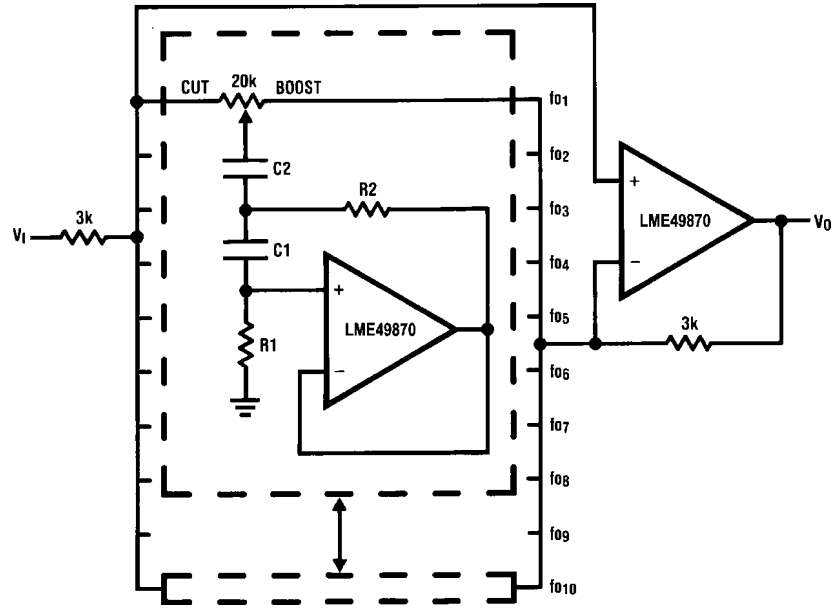
If  $R_2 = R_5$ ,  $R_3 = R_6$ ,  $R_4 = R_7$

$$V_0 = \left( 1 + \frac{2R_2}{R_1} \right) \frac{R_4}{R_3} (V_2 - V_1)$$

Illustration is:

$$V_0 = 101(V_2 - V_1)$$

10 Band Graphic Equalizer



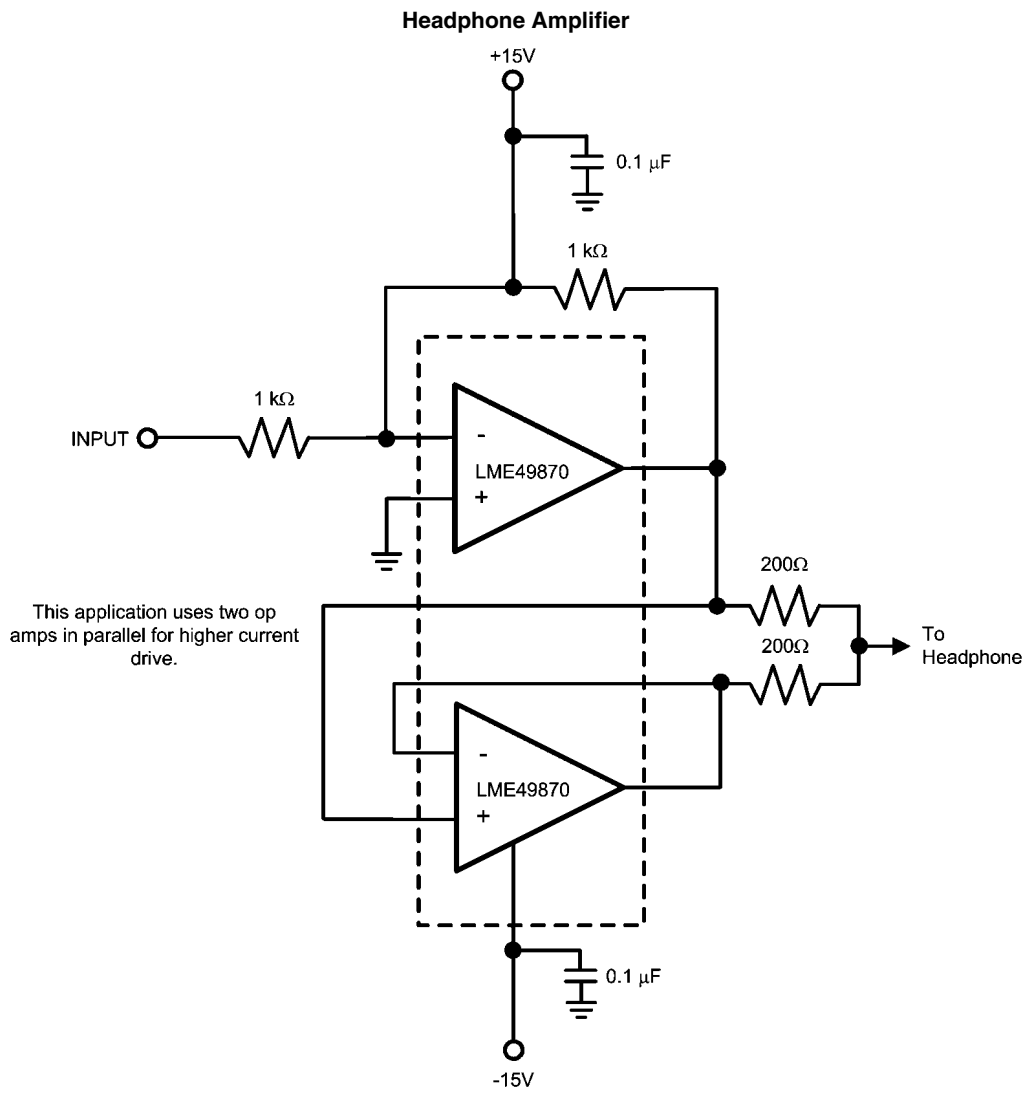
30019444

fo (Hz)	C <sub>1</sub>	C <sub>2</sub>	R <sub>1</sub>	R <sub>2</sub>
32	0.12μF	4.7μF	75kΩ	500Ω
64	0.056μF	3.3μF	68kΩ	510Ω
125	0.033μF	1.5μF	62kΩ	510Ω
250	0.015μF	0.82μF	68kΩ	470Ω
500	8200pF	0.39μF	62kΩ	470Ω
1k	3900pF	0.22μF	68kΩ	470Ω
2k	2000pF	0.1μF	68kΩ	470Ω
4k	1100pF	0.056μF	62kΩ	470Ω
8k	510pF	0.022μF	68kΩ	510Ω
16k	330pF	0.012μF	51kΩ	510Ω

**Note 9:** At volume of change = ±12 dB

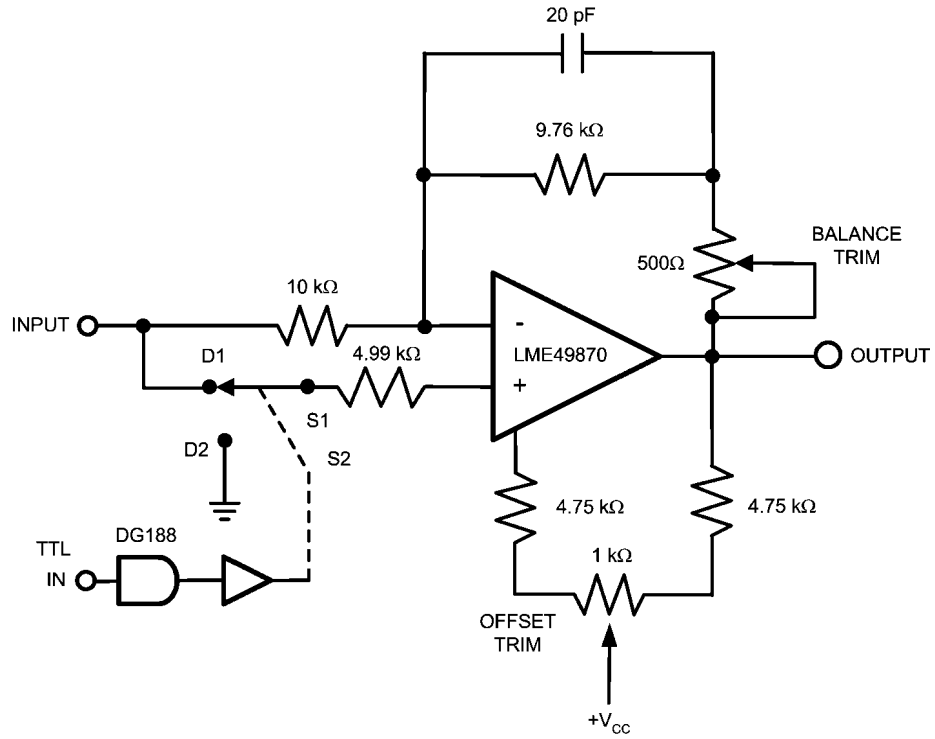
Q = 1.7

Reference: "AUDIO/RADIO HANDBOOK", National Semiconductor, 1980, Page 2-61



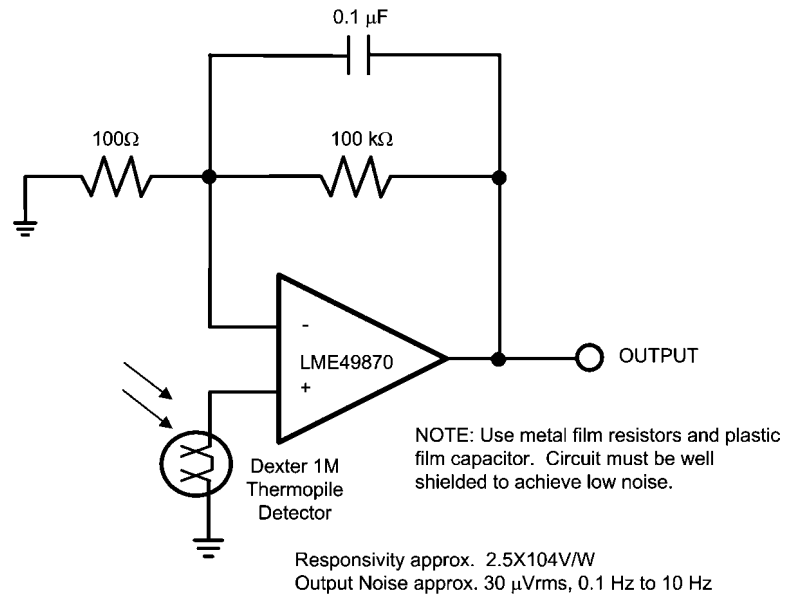
30019410

### High Performance Synchronous Demodulator



30019411

### Long-Wavelength Infrared Detector Amplifier



30019412

## Revision History

Rev	Date	Description
1.0	09/20/07	Initial release.
1.1	09/27/07	Updated Notes 1–7 (per National standard).
1.2	12/20/07	Deleted all Crosstalk vs Frequency curves.
1.3	01/14/08	Edited some graphics.





# Notes

LME49870

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